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#### **TEST REPORT**

## FCC Part 22 Subpart H / Part 24 Subpart E / Part 27

Report Reference No...... CTL1403250553-WU

Compiled by

( position+printed name+signature)..: File administrators Jacky Chen

Name of the organization performing

the tests

Test Engineer Tracy Qi

( position+printed name+signature)..:

Approved by

( position+printed name+signature)..: Manager Tracy Qi

Date of issue...... Apr. 15, 2014

Test Firm...... Shenzhen CTL Testing Technology Co., Ltd.

Address...... Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road,

Nanshan District, Shenzhen, China 518055

Applicant's name...... Bulltech Electronic Products S.L.

Address...... Gran Via, 64, 2-I, 28013 Madrid, Spain.

Test specification:

Standard ...... FCC CFR Title 47 Part 2, Part 22H, Part 24E and Part 27

EIA/TIA 603-C: 2004

Master TRF...... Dated 2011-01

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Test item description .....: SMART PHONE

FCC ID...... 2AAM3SYRENI50DCII

Trade Mark ...... SZENIO

Model/Type reference...... Syreni 50DC II

**GSM/WCDMA** 

3G:WCDMA Band V: 824~849MHz

3G:WCDMA Band V: 869~894MHz

Release Version ...... 2G:R99

3G:Rel-6

3G: QPSK

GPRS Type ...... Class B

GPRS Class ...... Class 12

**GPS** 

work frequency ...... 1575.42MHz

Type of modulation .....: BPSK

**Bluetooth** 

Work frequency ...... 2402~2480MHz

Wi-Fi

Data Rate...... 802.11b: 1/2/5.5/11 Mbps

802.11g: 6/9/12/18/24/36/48/54 Mbps

802.11n: up to 135 Mbps

Antenna Gain ...... -2.0 dBi for GSM850 and WCDMA Band V

-1.0 dBi for PCS1900

0 dBi for Bluetooth and Wi-Fi

Antenna type ...... Internal

Harware version ...... 8068-MB-V0.3

Software version.....: 8068-01C\_K77W\_OTD\_A999W\_BULLTECH\_QHD\_V008\_

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20140117\_1240

Result..... Positive

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### TEST REPORT

Test Report No. :	CTL1403250553-WU	Apr. 15, 2014		
	C1L1403230333-VVO	Date of issue		

Equipment under Test : SMART PHONE

Model /Type : Syreni 50DC II

Applicant : Bulltech Electronic Products S.L.

Address : Gran Via, 64, 2-I, 28013 Madrid, Spain.

Manufacturer : Shenzhen ODX Telecom Equipment Co., Ltd.

Address : 2nd Floor of Building B, HongLianYing Technology Park,

No. 286 of SiLi Road, DaBuXiang Community, Longhua

New District, Shenzhen, China

Test Result according to the standards on page 5:	Positive

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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	TEST SETUP PHOTOS OF THE EUT	
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# 1. TEST STANDARDS

The tests were performed according to following standards:

FCC Part 22 Subpart H: Public Mobile Services

FCC Part 24 Subpart E: Personal Communications Services

EIA/TIA 603-C: 2004

FCC CFR Title 47 Part 2



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# 2. <u>SUMMAR</u>Y

#### 2.1. General Remarks

Date of receipt of test sample	:	Mar. 25, 2014
Testing commenced on	:	Mar. 25, 2014
Testing concluded on	:	Apr. 15, 2014

### 2.2. Equipment Under Test

## Power supply system utilised

Power supply voltage : ● 120V / 60 Hz o 115V / 60Hz o 24 V DC

Other (specified in blank below)

DC 3.7V from battery

# 2.3. Short description of the Equipment under Test (EUT)

A SMART PHONE with WCDMA/GSM, Bluetooth, GPS and wifi function.

For more details, refer to the user's manual of the EUT.

Serial number: Prototype

# 2.4. EUT operation mode

CTL has verified the construction and function in typical operation. All the test modes were carried out with the EUT in normal operation, which was shown in this test report and defined as:

Test Mode	
Mode 1: GSM850	- child
Mode 2: PCS1900	esting Tech
Mode 3: GPRS850	and a second
Mode 4: GPRS1900	
Mode 5: EDGE850	
Mode 6: EDGE1900	
Mode 7: WCDMA Band V	
Mode 8: HSDPA Band V	
Mode 9: HSUPA Band V	

#### Note:

- 1. Regards to the frequency band operation: the lowest, middle and highest frequency of channel were selected to perform the test, then shown on this report.
- 2. For the ERP/EIRP and radiated emission test, every axis (X, Y, Z) was verified, and show the worst result on this report.
- 3. This device is a composite device in accordance with Part 15 Subpart B regulations.

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## 2.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

o - supplied by the manufacturer

o - supplied by the lab

o Manufacturer:

Model No.:

o Manufacturer :

Model No.:

## 2.6. Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended for FCC ID: 2AAM3SYRENI50DCII filing to comply with of the FCC Part 22 and Part 24 Rules.

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#### 2.7. Modifications

No modifications were implemented to meet testing criteria.

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# 3. TEST ENVIRONMENT

### 3.1. Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.

Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, China 518055

The sites are constructed in conformance with the requirements of ANSI C6230, ANSI C63.4 (2003) and CISPR Publication 22.

## 3.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

## IC Registration No.: 9618B

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration No.: 9618B on November 13, 2013.

#### FCC-Registration No.: 970318

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 970318, December 19, 2013.

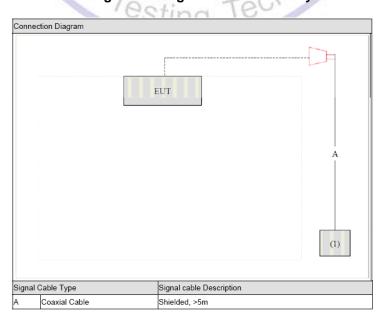
#### 3.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature: \_\_\_\_\_15-35 ° C Humidity: \_\_\_\_\_30-60 % Atmospheric pressure: \_\_\_\_\_950-1050mbar

# 3.4. Configuration of Tested System

Fig. 2-1 Configuration of Tested System



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#### 3.5. EUT Exercise Software

- 1. Setup the EUT and simulators as shown on above.
- 2. Turn on the power of all equipment.
- 3. EUT Communicate with CMU200, then select channel to test.

#### 3.6. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods — Part 4: Uncertainty in EMC Measurements" and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10dB	(1)
Radiated Emission	Above 1GHz	4.32dB	(1)
Conducted Disturbance	0.15~30MHz	3.20dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



# 3.7. Equipments Used during the Test

Test Equipment	Equipment Manufacturer		Serial No.	Calibration Date	Calibration Due Date
Bilog Antenna	Sunol Sciences Corp.	JB1	A061713	2013/07/12	2014/07/11
EMI Test Receiver	R&S	ESCI	103710	2013/07/10	2014/07/09
Spectrum Analyzer	Agilent	E4407B	MY45108355	2013/07/06	2014/07/05
Controller	EM Electronics	Controller EM 1000	N/A	2013/07/06	2014/07/05
Horn Antenna	Sunol Sciences Corp.	DRH-118	A062013	2013/07/12	2014/07/11
Horn Antenna	SCHWARZBECK	BBHA9170	1562	2013/07/12	2014/07/11
Active Loop Antenna	SCHWARZBECK	FMZB1519	1519-037	2013/07/12	2014/07/11
LISN	R&S	ENV216	101316	2013/07/10	2014/07/09
LISN	SCHWARZBECK	NSLK8127	8127687	2013/07/10	2014/07/09
Microwave Preamplifier	HP +A	8349B	3155A00882	2013/07/10	2014/07/09
Amplifier	HP (1)	8447D	3113A07663	2013/07/10	2014/07/09
Transient Limiter	Com-Power	LIT-153	532226	2013/07/10	2014/07/09
Radio Communication Tester	R&S	CMU200	3655A03522	2013/07/06	2014/07/05
Temperature/Humidity Meter	zhicheng	ZC1-2	22522	2013/07/10	2014/07/09
SIGNAL GENERATOR	HP I	8647A	3200A00852	2013/07/10	2014/07/09
Wideband Peak Power Meter	Anritsu	ML2495A	220.23.35	2013/07/06	2014/07/05
Climate Chamber	ESPEC	EL-10KA	A20120523	2013/07/06	2014/07/05
High-Pass Filter	K&L	9SH10- 2700/X12750 -O/O	100	2013/07/06	2014/07/05
High-Pass Filter	K&L	41H10- 1375/U12750 -O/O	Chro.	2013/07/06	2014/07/05

No deviations from the test standards

For GSM 850/WCDMA Band V (FCC Part 22H & Part 2)

Emission						
Performed Item	Normative References	Test Performed	Deviation			
Peak Output Power	FCC Part 22.913(a)(2) and Part 2.1046 EIA/TIA 603-C	Yes	No			
Modulation Characteristic	FCC Part 2.1047(d)	Yes	No			
Occupied Bandwidth	FCC Part 2.1049	Yes	No			
Spurious Emission At Antenna Terminals (+/- 1MHz)	FCC Part 22.917(a) and Part 2.1049	Yes	No			
Spurious Emission	FCC Part 22.917(b) and Part 2.1051, 2.1053 EIA/TIA 603-C	Yes	No			
Frequency Stability Under Temperature & Voltage Variations	FCC Part 22.355 and 2.1055 EIA/TIA 603-C	Yes	No			

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# For PCS 1900 (FCC Part 24E & Part 2)

Emission						
Performed Item	Normative References	Test Performed	Deviation			
Peak Output Power	FCC Part 24.232(b) and Part 2.1046 EIA/TIA 603-C	Yes	No			
Modulation Characteristic	FCC Part 2.1047(d)	Yes	No			
Occupied Bandwidth	FCC Part 24.238(b) and Part 2.1049	Yes	No			
Spurious Emission At Antenna Terminals (+/- 1MHz)	FCC Part 24.238(a) and Part 2.1049	Yes	No			
Spurious Emission	FCC Part 24.238(b) and Part 2.1051, 2.1053 EIA/TIA 603-C	Yes	No			
Frequency Stability Under	FCC Part 24.235 and 2.1055	Yes	No			
Temperature & Voltage	EIA/TIA 603-C					

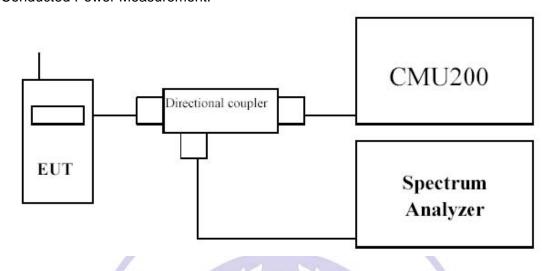
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# 4. TEST CONDITIONS AND RESULTS

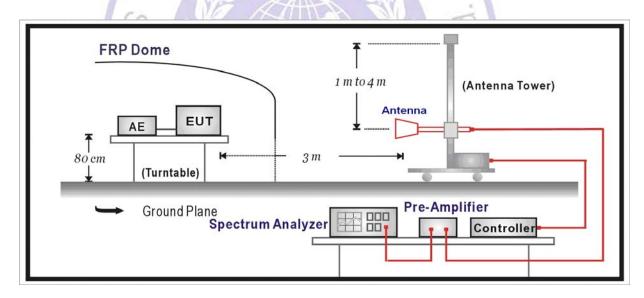
# 4.1. Peak Output Power

#### **TEST CONFIGURATION**

Conducted Power Measurement:



Radiated Power Measurement:



#### **TEST PROCEDURE**

The EUT was setup according to EIA/TIA 603C

#### **Conducted Power Measurement:**

- a) Place the EUT on a bench and set it in transmitting mode.
- b) Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMU200 by a Directional Couple.
- c) EUT Communicate with CMU200, then select a channel for testing.
- d) Add a correction factor to the display of spectrum, and then test.

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#### **Radiated Power Measurement:**

- a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b) The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c) The output of the test antenna shall be connected to the measuring receiver.
- d) The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e) The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- f) The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- g) The test antenna shall be raised and lowered again through the specified range of height until a maximum signal level is detected by the measuring receiver.
- h) The maximum signal level detected by the measuring receiver shall be noted.
- i) The transmitter shall be replaced by a substitution antenna.
- j) The substitution antenna shall be orientated for vertical polarization and the length of the substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k) The substitution antenna shall be connected to a calibrated signal generator.
- I) If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to increase the sensitivity of the measuring receiver.
- m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n) The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o) The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p) The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- g) Test site anechoic chamber refer to ANSI C63.4: 2003.

## Base station simulator settings for each test mode:

1. For GSM/GPRS

Configure R&S CMU200 to support GMSK call respectively, and set one timeslot transmission for GMSK GSM/GPRS.

Measure and record power outputs for both modulations.

2. For WCDMA

Configure the CMU-200 to support all WCDMA tests in respect to the 3GPP 34.121. Measure the EUT output power at 826.4MHz, 836.6MHz and 846.6MHz for WCDMA Band V,.

#### For Rel 99

- Set a Test Mode 1 loop back with a 12.2kbps Reference Measurement Channel (RMC)
- Set and send continuously Up power control commands to the Gobi2000
- Measure the power at the Gobi2000 Module antenna connector by using CMU-200.

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### <u>LIMIT</u>

For FCC Part 22.913(a)(2):

The ERP of mobile transmitters and auxiliary test transmitters must not exceed 7 Watts.

For FCC Part 24.232(b):

The EIRP of mobile transmitters and auxiliary test transmitters must not exceed 2 Watts.

#### **TEST RESULTS**

#### **Conducted Power Measurement**

### **GSM 850**

Test Mode	Channel No.	Frequency (MHz)	Modulation	Conducted Power (dBm)
	128	824.2	GMSK	32.58
GSM 850	189	836.4	GMSK	32.79
	251	848.8	GMSK	32.85
	512	1850.2	GMSK	29.81
GSM 1900	661	1880.0	GMSK	29.97
	810	1909.8	GMSK	30.16
	128	824.2	GMSK	32.57
GPRS 850	189	836.4	GMSK	32.78
	251	848.8	GMSK	32.84
	512	1850.2	GMSK	29.79
GPRS 1900	661	1880.0	GMSK	29.95
	810	1909.8	GMSK	30.15
_	128	824.2	8PSK	26.51
EDGE 850	189	836.4	8PSK	26.73
31	251	848.8	8PSK	26.81
N N	512	1850.2	8PSK	25.75
EDGE 1900	661	1880.0	8PSK	25.97
	810	1909.8	8PSK	26.14

Note: The maximum PAR for GPRS 1900 is 7.8dB less than 13 dB, and the maximum PAR for EDGE 1900 is 7.9dB less than 13 dB.

#### WCDMA/HSDPA/HSUPA

		Band			
Mode	3GPP Subtest	Con	MPR		
		4132	4182	4233	
WCDMA R99	1	22.66	22.89	21.5	N/A
Rel5 HSDPA	1	21.64	21.84	21.46	0
	2	21.31	21.48	21.29	0
	3	21.38	21.46	21.32	0.5
	4	21.36	21.41	21.32	0.5
	1	21.87	21.87	21.43	0
	2	20.16	20.13	19.89	2
Rel6 HSUPA	3	20.21	20.19	20.16	1
	4	20.15	20.19	20.03	2
	5	21.12	21.15	21.01	0

Note: All conducted measurements are based on a RMS detector.



## Radiated Measurement

# GSM 850

Frequency	SA	Ant. Pol.	SG	Cable	Gain	ERP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBd)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Chann	nel 128 (82	24.20MHz	)					
824.2	30.37	Н	25.81	1.78	6.52	30.55	38.5	-7.95
824.2	30.95	V	25.82	1.78	6.38	30.42	38.5	-8.08
Middle Cha	annel 189	(836.40MI	Hz)					
836.4	30.40	Н	25.40	1.80	6.63	30.23	38.5	-8.27
836.4	31.13	V	25.81	1.80	6.15	30.16	38.5	-8.34
High Chan	High Channel 251 (848.80MHz)							
848.8	29.81	Н	25.45	1.82	6.80	30.43	38.5	-8.07
848.8	30.19	V	25.59	1.82	6.54	30.31	38.5	-8.19

## GSM 1900

Frequency	SA	Ant .Pol.	SG	Cable	Gain	EIRP	Limit	Margin	
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)	
	(dBm)		(dBm)	(dB)					
Low Chan	Low Channel 512 (1850.20MHz)								
1850.2	16.25	H	26.65	2.70	4.64	28.59	33.0	-4.41	
1850.2	17.31	V	26.22	2.70	4.64	28.16	33.0	-4.84	
Middle Cha	annel 661	(1880.00N)	ИHz)	100	V Day	11			
1880	18.37	<pre>// H_//</pre>	26.90	2.72	4.59	28.77	33.0	-4.23	
1880	15.22	/ V	26.29	2.72	4.59	28.16	33.0	-4.84	
High Chan	High Channel 810 (1909.80MHz)								
1909.8	15.42	H. S	26.75	2.75	4.54	28.54	33.0	-4.46	
1909.8	17.63	V	26.69	2.75	4.54	28.48	33.0	-4.52	

# GPRS 850

		10 The Control of the		3927	EVALUE 1 III /4	T Service Control			
Frequency		Ant. Pol.	SG :	Cable	Gain	ERP	Limit	Margin	
(MHz)	Reading	(H/V)	Reading	Loss	(dBd)	(dBm)	(dBm)	(dB)	
	(dBm)		(dBm)	(dB)					
Low Chann	nel 128 (82	24.20MHz	1100			7			
824.2	30.40	△H ✓	25.84	1.78	6.52	30.58	38.5	-7.92	
824.2	30.94	CV	25.81	1.78	6.38	30.41	38.5	-8.09	
Middle Cha	nnel 189	(836.40MI	Hz)		Val.	V			
836.4	30.47	H	25.47	1.80	6.63	30.30	38.5	-8.20	
836.4	31.15	V	25.83	1.80	6.15	30.18	38.5	-8.32	
High Chan	High Channel 251 (848.80MHz)								
848.8	29.86	Н	25.50	1.82	6.80	30.48	38.5	-8.02	
848.8	30.25	V	25.65	1.82	6.54	30.37	38.5	-8.13	

## **GPRS 1900**

Frequency		Ant .Pol.	SG	Cable	Gain	EIRP	Limit	Margin		
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)		
	(dBm)		(dBm)	(dB)						
Low Channel 512 (1850.20MHz)										
1850.2	16.27	Н	26.67	2.70	4.64	28.61	33.0	-4.39		
1850.2	17.90	V	26.81	2.70	4.64	28.75	33.0	-4.25		
Middle Cha	annel 661	(1880.00N	ИHz)							
1880	18.53	Н	27.06	2.72	4.59	28.93	33.0	-4.07		
1880	15.64	V	26.71	2.72	4.59	28.58	33.0	-4.42		
High Chan	High Channel 810 (1909.80MHz)									
1909.8	15.15	Н	26.48	2.75	4.54	28.27	33.0	-4.73		
1909.8	16.80	V	25.86	2.75	4.54	27.65	33.0	-5.35		

## **EDGE 850**

Frequency	SA	Ant. Pol.	SG	Cable	Gain	ERP	Limit	Margin		
(MHz)	Reading	(H/V)	Reading	Loss	(dBd)	(dBm)	(dBm)	(dB)		
	(dBm)		(dBm)	(dB)						
Low Chann	Low Channel 128 (824.20MHz)									
824.2	24.38	Н	19.82	1.78	6.52	24.56	38.5	-13.94		
824.2	24.97	V	19.84	1.78	6.38	24.44	38.5	-14.06		
Middle Cha	annel 189	(836.40MI	Hz)							
836.4	24.48	Н	19.48	1.80	6.63	24.31	38.5	-14.19		
836.4	25.19	V	19.87	1.80	6.15	24.22	38.5	-14.28		
High Chan	High Channel 251 (848.80MHz)									
848.8	23.84	Н	19.48	1.82	6.80	24.46	38.5	-14.04		
848.8	24.18	V	19.58	1.82	6.54	24.30	38.5	-14.20		

## **EDGE 1900**

SA	Ant .Pol.	00					
		SG	Cable	Gain	EIRP	Limit	Margin
Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
(dBm)		(dBm)	(dB)				
nel 512 (	1850.20N	/IHz)					
11.98	H	18.38	2.70	4.64	24.32	33.0	-8.68
12.97	V	17.88	2.70	4.64	23.82	33.0	-9.18
nnel 661	(1880.001	ЛHz)					
14.01	H	18.54	2.72	4.59	24.41	33.0	-8.59
11.14	V/V	18.21	2.72	4.59	24.08	33.0	-8.92
nel 810 (1	909.80MH	lz)			19		
11.00	HY	18.33	2.75	4.54	24.12	33.0	-8.88
13.23	V	18.29	2.75	4.54	24.08	33.0	-8.92
		Testi	ng T	ech	10105	7.05	
	(dBm) nel 512 ( 11.98 12.97 nnel 661 14.01 11.14 nel 810 (1 11.00 13.23	(dBm) nel 512 (1850.20M 11.98	(dBm)     (dBm)       nel 512 (1850.20MHz)       11.98     H     18.38       12.97     V     17.88       annel 661 (1880.00MHz)       14.01     H     18.54       11.14     V     18.21       nel 810 (1909.80MHz)       11.00     H     18.33       13.23     V     18.29	(dBm)         (dBm)         (dB)           nel 512 (1850.20MHz)         11.98         H         18.38         2.70           12.97         V         17.88         2.70           nnel 661 (1880.00MHz)         14.01         H         18.54         2.72           11.14         V         18.21         2.72           nel 810 (1909.80MHz)         11.00         H         18.33         2.75           13.23         V         18.29         2.75	(dBm)     (dBm)     (dB)       nel 512 (1850.20MHz)       11.98     H     18.38     2.70     4.64       12.97     V     17.88     2.70     4.64       annel 661 (1880.00MHz)       14.01     H     18.54     2.72     4.59       11.14     V     18.21     2.72     4.59       nel 810 (1909.80MHz)       11.00     H     18.33     2.75     4.54       13.23     V     18.29     2.75     4.54	(dBm)     (dBm)     (dB)       nel 512 (1850.20MHz)       11.98     H     18.38     2.70     4.64     24.32       12.97     V     17.88     2.70     4.64     23.82       annel 661 (1880.00MHz)       14.01     H     18.54     2.72     4.59     24.41       11.14     V     18.21     2.72     4.59     24.08       nel 810 (1909.80MHz)       11.00     H     18.33     2.75     4.54     24.12       13.23     V     18.29     2.75     4.54     24.08	(dBm)     (dBm)     (dB)       nel 512 (1850.20MHz)       11.98     H     18.38     2.70     4.64     24.32     33.0       12.97     V     17.88     2.70     4.64     23.82     33.0       annel 661 (1880.00MHz)       14.01     H     18.54     2.72     4.59     24.41     33.0       11.14     V     18.21     2.72     4.59     24.08     33.0       nel 810 (1909.80MHz)       11.00     H     18.33     2.75     4.54     24.12     33.0       13.23     V     18.29     2.75     4.54     24.08     33.0

# WCDMA Band V

Frequency	SA	Ant .Pol.	SG	Cable	Gain	ERP	Limit	Margin	
(MHz)	Reading	(H/V)	Reading	Loss	(dBd)	(dBm)	(dBm)	(dB)	
	(dBm)		(dBm)	(dB)					
Low Chann	el 4132 (82	26.40MHz)							
826.4	21.33	Н	16.74	1.79	6.50	21.45	38.5	-17.05	
826.4	22.00	V	16.87	1.79	6.30	21.38	38.5	-17.12	
Middle Cha	nnel 4182	(836.40MF	łz)						
836.4	21.65	Н	16.65	1.80	6.63	21.48	38.5	-17.02	
836.4	22.24	٧	16.93	1.80	6.14	21.27	38.5	-17.23	
High Chani	High Channel 4233 (846.60MHz)								
846.6	20.11	Н	15.54	1.82	6.80	20.52	38.5	-17.98	
846.6	20.40	٧	15.65	1.82	6.51	20.34	38.5	-18.16	

### **WCDMA Band V HSDPA**

Frequency	SA	Ant .Pol.	SG	Cable	Gain	ERP	Limit	Margin
(MHz)	Reading (dBm)	(H/V)	Reading (dBm)	Loss (dB)	(dBd)	(dBm)	(dBm)	(dB)
Low Chann	el 4132 (8	26.40MHz)	,		<u>'</u>	•		
826.4	21.40	Н	16.81	1.79	6.50	21.52	38.5	-16.98
826.4	21.98	٧	16.85	1.79	6.30	21.36	38.5	-17.14
Middle Cha	nnel 4182	(836.40MH	lz)		7			
836.4	21.63	H	16.63	1.80	6.63	21.46	38.5	-17.04
836.4	22.19	٧	16.88	1.80	6.14	21.22	38.5	-17.28
High Chani	nel 4233 (8	46.60MHz	100	- 0	100			
846.6	20.13	H) /	15.56	1.82	6.80	20.54	38.5	-17.96
846.6	20.39	V	15.64	1.82	6.51	20.33	38.5	-18.17

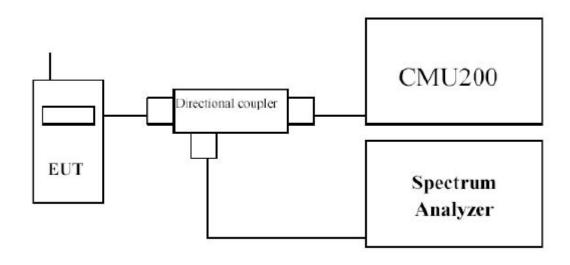
# WCDMA Band V HSUPA

Frequency	SA	Ant .Pol.	SG	Cable	Gain	ERP	Limit	Margin
` '	Reading (dBm)	(H/V)	Reading (dBm)	Loss (dB)	(dBd)	(dBm)	(dBm)	(dB)
Low Chann		26.40MHz)		(GD)	W/A	144		
826.4	21.36	H	16.77	1.79	6.50	21.48	38.5	-17.02
826.4	21.96	V	16.83	1.79	6.30	21.34	38.5	-17.16
Middle Cha	nnel 4182	(836.40MH	lz)		18	2		•
336.4	21.68	H	16.68	1.80	6.63	21.51	38.5	-16.99
336.4	22.19	V	16.88	1.80	6.14	21.22	38.5	-17.28
High Chanr	nel 4233 (8	846.60MHz			The same of the sa	10	/	•
846.6	20.15	H //	15.58	1.82	6.80	20.56	38.5	-17.94
846.6	20.38	V	15.63	1.82	6.51	20.32	38.5	-18.18

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#### 4.2. Modulation Characteristic

#### **TEST CONFIGURATION**



#### **LIMIT**

N/A

#### **TEST PROCEDURE**

GMSK is a form of binary signaling schemes which represent digital states as a shift between discrete sinusoidal frequencies called Frequency Shift Keying (FSK). Minimum Shift Keying (MSK) is continuous phase FSK with the smallest possible modulation index h. Modulation index is defined as: h = 2\*F\*Tb

where F = Peak frequency deviation in Hz and Tb = Bit period in seconds

Two discrete frequencies, representing two distinct digital states, with equal phases at switch time t=0 requires a minimum value of h=0.5. The Gaussian part of GMSK describes the fact that the digital pulses are filtered in the time domain. This results in bits which are sinusoidal rather than square. The effective spectrum is then compressed with the average carrier frequency in the center of the passband. This is a great advantage because of the significantly reduced bandwidth. GMSK is utilized because of these bandwidth conservation properties.

The bandwidth for GSM is a 60 MHz up-link at 1850-1910 MHz and down-link at 1930-1990 MHz. The 65 MHz is divided into 299 channels, each of which is 200 kHz wide. Slight spectral spillage is allowed into neighboring channels (which is minimized by GMSK). This separated transmit/receive frequencies scheme under GSM enables easier duplex filtering.

Within the bandwidth, individual channels are subdivided into multiframes (made of 26 frames), frames (made of 8 time slots), and time slots (made of 8 fields). The time slots are 0.57 ms long allowing 156.25 bits of information including overhead.

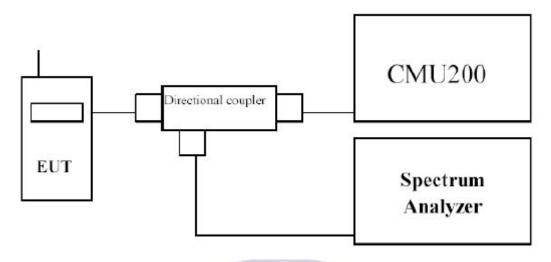
#### **TEST RESULTS**

The modulation of GSM/WCDMA was verified and confirmed compliance with requirement.

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## 4.3. Occupied Bandwidth

## **TEST CONFIGURATION**



### **TEST PROCEDURE**

Using Occupied Bandwidth measurement function of spectrum analyzer, and setting as follows:

For GPRS 850/1900 test --- RBW = 3 kHz and VBW = 10 kHz

For WCDMA FDD Band II/IV/V test --- RBW = 50 kHz and VBW = 200 kHz

### **LIMIT**

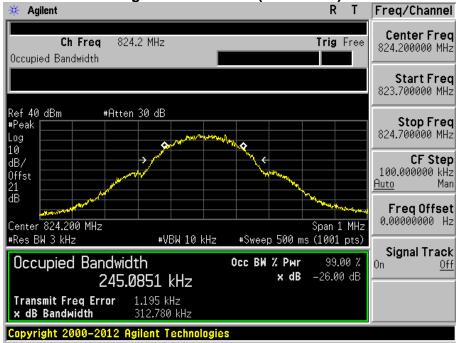
N/A

#### **TEST RESULTS**

Product	SMART PHONE
Test Item	Occupied Bandwidth
Test Mode	Mode 1: GSM 850 Link
Date of Test	2014/04/03 Test Site TR3

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
128	824.20	312.780	245.085
189	836.40	309.750	244.302
251	848.80	316.857	244.808

Figure Channel 128 (824.20MHz)



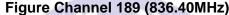




Figure Channel 251 (848.80MHz)





Product	SMART PHONE		
Test Item	Occupied Bandwidth		
Test Mode	Mode 2: GSM 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
512	1850.20	314.079	245.970
661	1880.00	319.430	244.030
810	1909.80	317.105	245.153



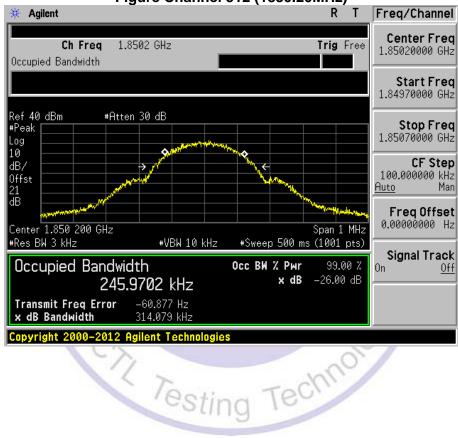
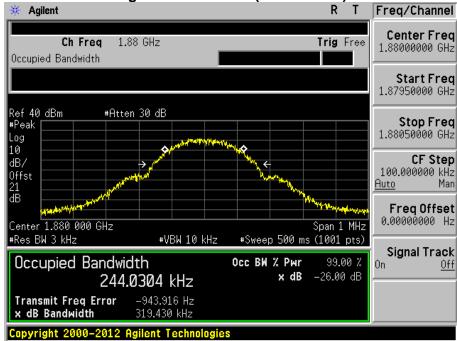
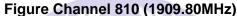


Figure Channel 661 (1880.00MHz)







2014/04/03

**SMART PHONE** 

Occupied Bandwidth

Mode 3: GPRS 850 Link

Product

Test Item

Test Mode

Date of Test

TR3

Report No.: CTL1403250553-WU

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
128	824.20	314.675	244.050
189	836.40	307.280	243.494
251	848.80	312.753	246.124

Test Site



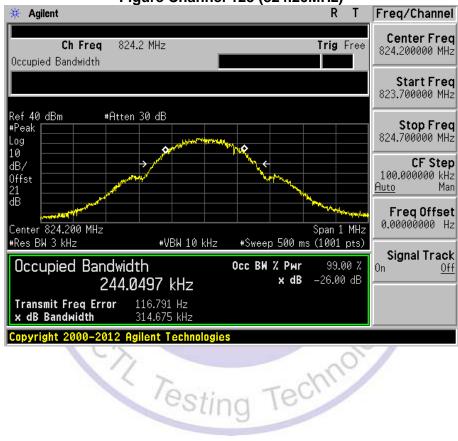
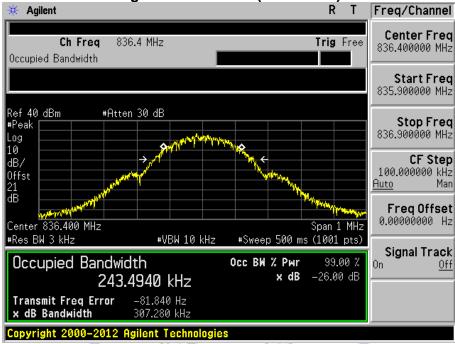
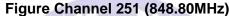


Figure Channel 189 (836.40MHz)





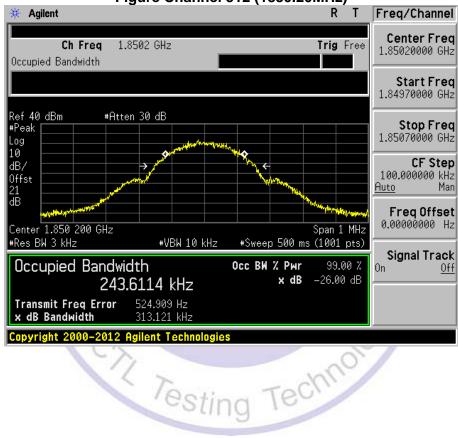


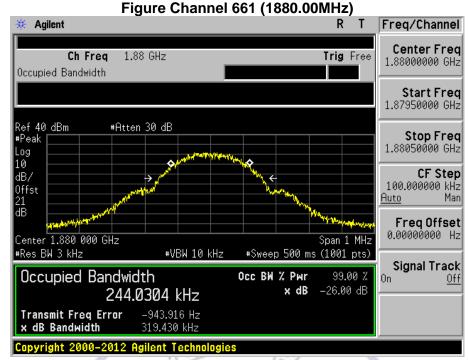
Product	SMART PHONE			
Test Item	Occupied Bandwidth			
Test Mode	Mode 4: GPRS 1900 Link			
Date of Test	2014/04/03	Test Site	TR3	

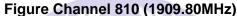
Report No.: CTL1403250553-WU

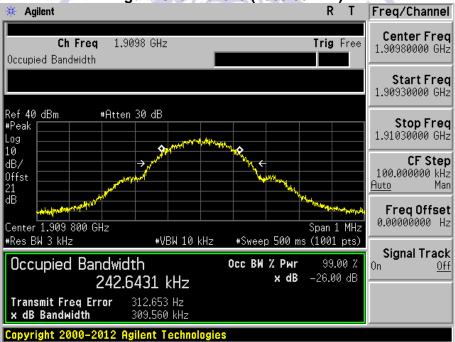
Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
512	1850.20	313.121	243.611
661	1880.00	319.430	244.030
810	1909.80	309.560	242.643











Product	SMART PHONE		
Test Item	Occupied Bandwidth		
Test Mode	Mode 5: EDGE 850 Link		
Date of Test	2014/04/03	Test Site	TR3

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
128	824.20	314.675	244.050
189	836.40	312.166	242.092
251	848.80	317.195	246.657



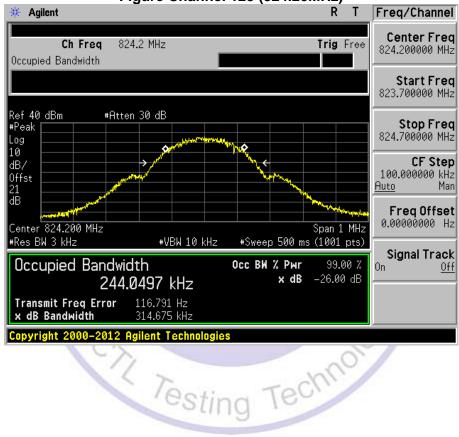
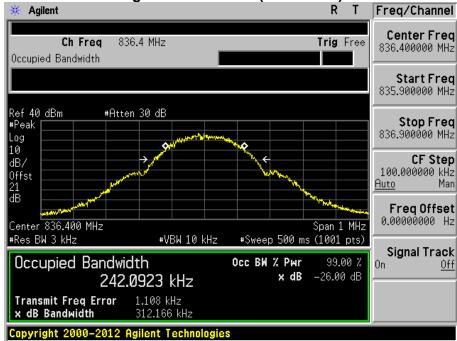
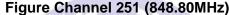


Figure Channel 189 (836.40MHz)







**SMART PHONE** 

2014/04/03

810

Occupied Bandwidth Mode 6: EDGE 1900 Link

Product

Test Item

Test Mode

Date of Test

TR3

241.215

Report No.: CTL1403250553-WU

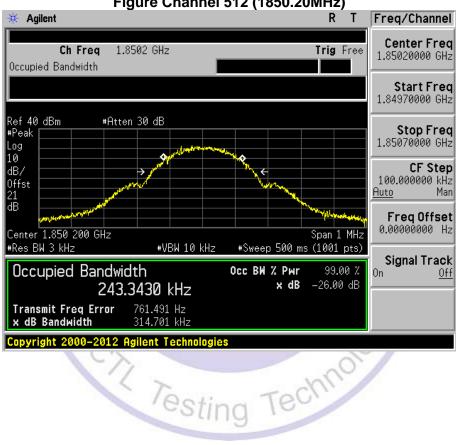
	Fraguency	-26dB Occupied	99% Occupied
Channel No.	Frequency (MHz)	Bandwidth	Bandwidth
	(IVITZ)	(kHz)	(kHz)
512	1850.20	314.701	243.343
661	1880 00	310 373	246 153

**Test Site** 

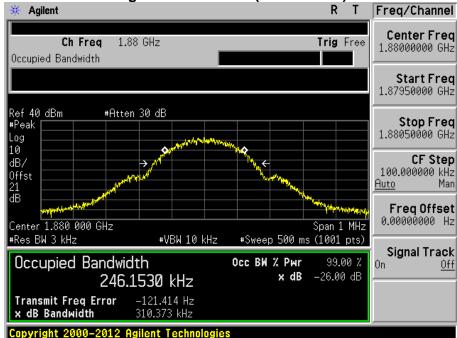
309.507



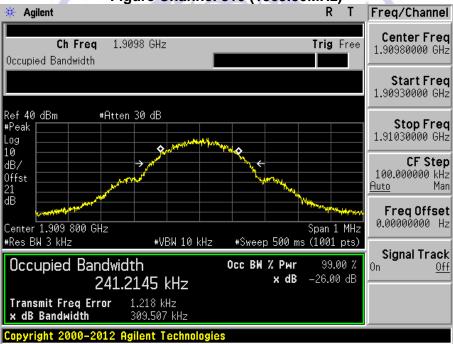
1909.80







### Figure Channel 810 (1909.80MHz)



Product	SMART PHONE		
Test Item	Occupied Bandwidth		
Test Mode	Mode 7: WCDMA Band V Link		
Date of Test	2014/04/03	Test Site	TR3

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
4132	826.4	4646.000	4141.900
4182	836.4	4659.000	4138.300
4233	846.6	4648.000	4139.000



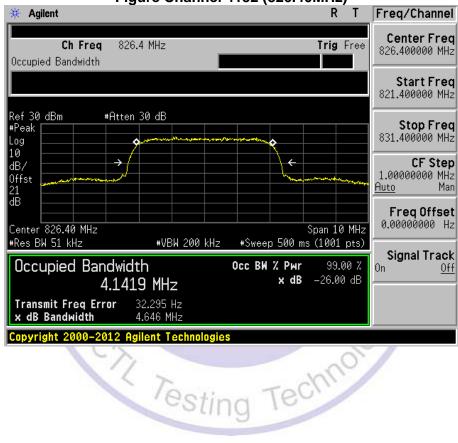
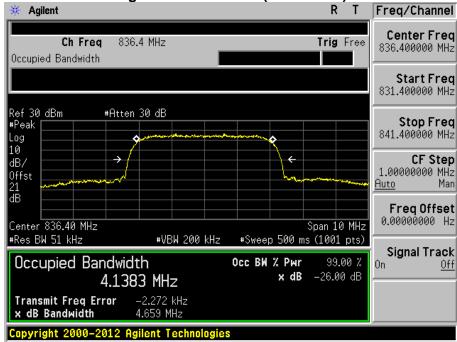
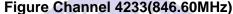
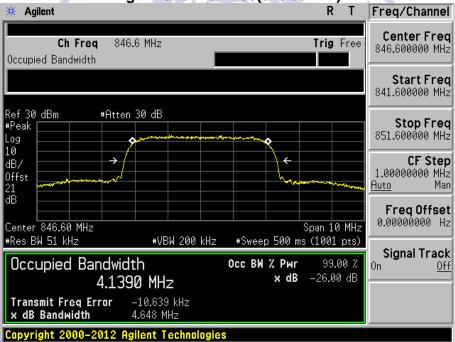


Figure Channel 4182 (836.40MHz)





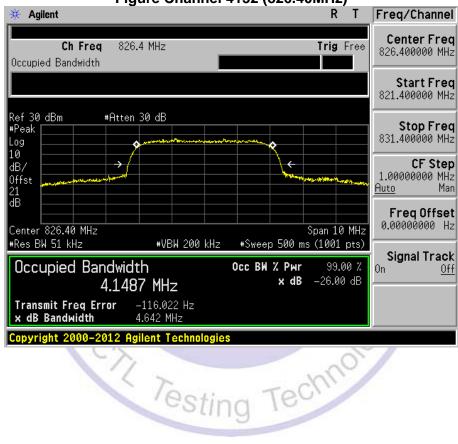


Report No.:	CTL1403250553-WU
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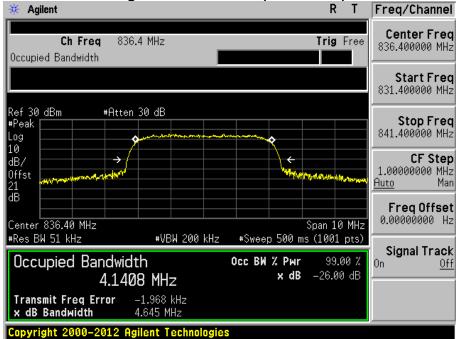
Product	SMART PHONE		
Test Item	Occupied Bandwidth		
Test Mode	Mode 8: WCDMA Band V HSDPA Link		
Date of Test	2014/04/03	Test Site	TR3

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
4132	826.4	4642.000	4148.700
4182	836.4	4645.000	4140.800
4233	846.6	4645.000	4142.400

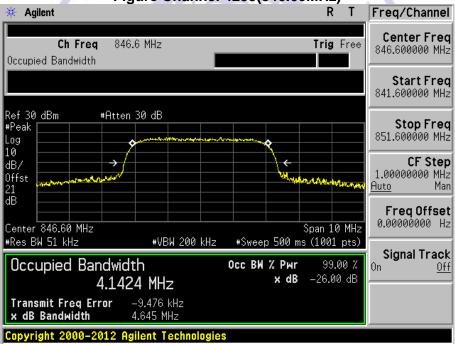
**Figure Channel 4132 (826.40MHz)** 







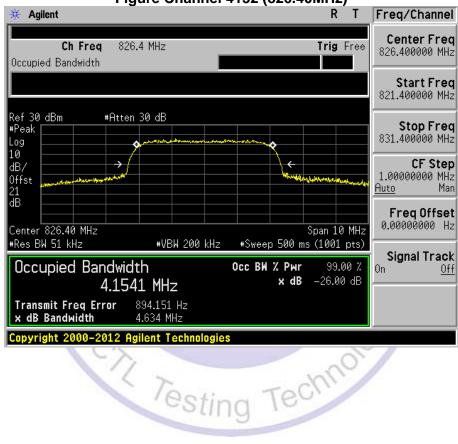
## Figure Channel 4233(846.60MHz)



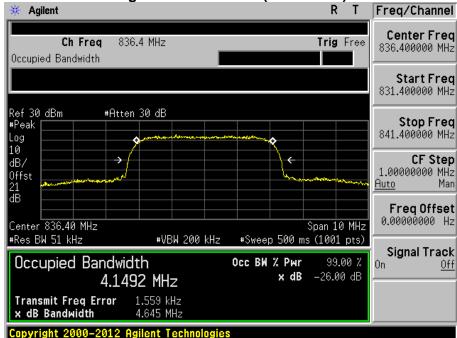
Product	SMART PHONE			
Test Item	Occupied Bandwidth			
Test Mode	Mode 9: WCDMA Band V	HSUPA Link		
Date of Test	2014/04/03	Test Site	TR3	

Channel No.	Frequency (MHz)	-26dB Occupied Bandwidth (kHz)	99% Occupied Bandwidth (kHz)
4132	826.4	4634.000	4154.100
4182	836.4	4645.000	4149.200
4233	846.6	4645.000	4148.100

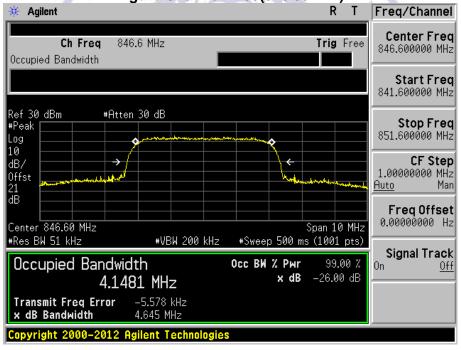








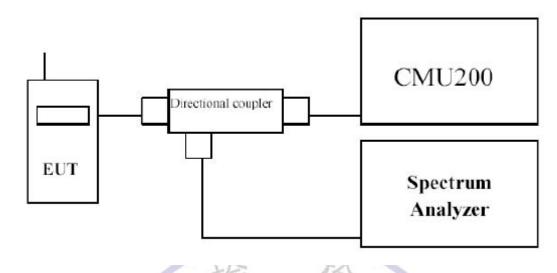
# Figure Channel 4233(846.60MHz)



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# 4.4. Band Edge

# **TEST CONFIGURATION**



## **TEST PROCEDURE**

In the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.

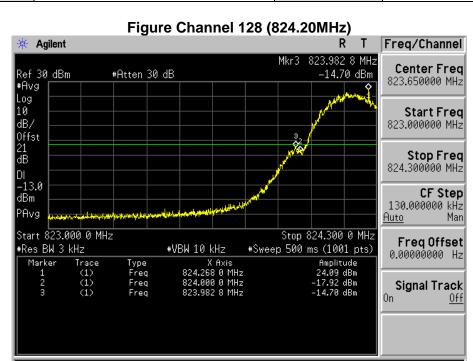
## **LIMIT**

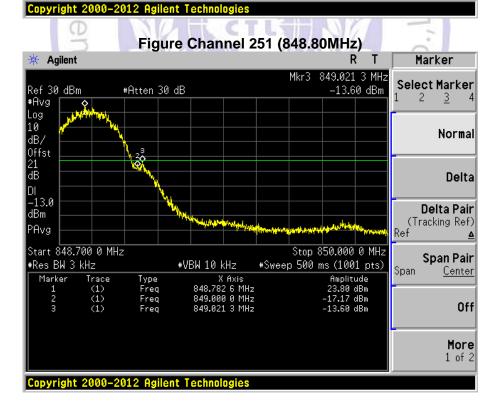
The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10log(P) dB.

Testing Technology

## **TEST RESULTS**

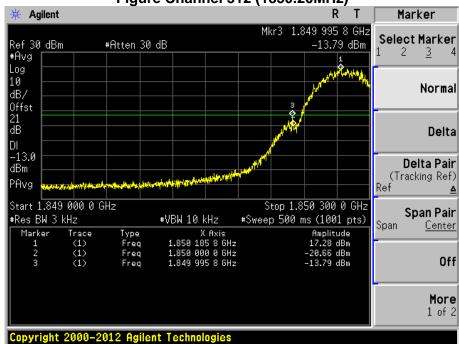
Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 1: GSM 850 Link			
Date of Test	2014/04/03	Test Site	TR3	

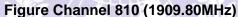




Product	SMART PHONE		
Test Item	Band Edge		
Test Mode	Mode 2: GSM 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

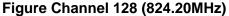


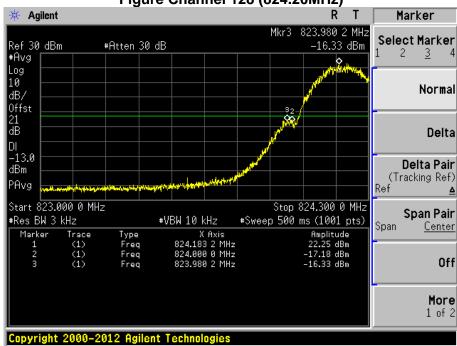


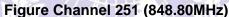


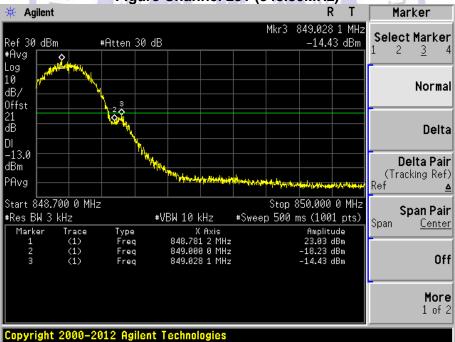


Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 3: GPRS 850 Link			
Date of Test	2014/04/03	Test Site	TR3	



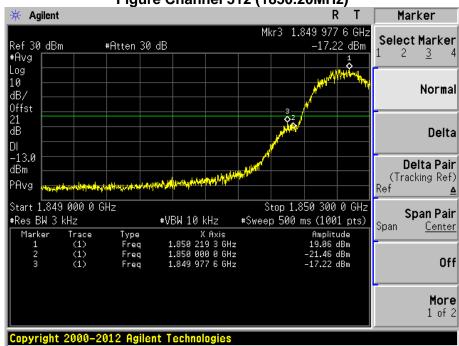


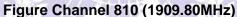




Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 4: GPRS 1900 Link			
Date of Test	2014/04/03	Test Site	TR3	



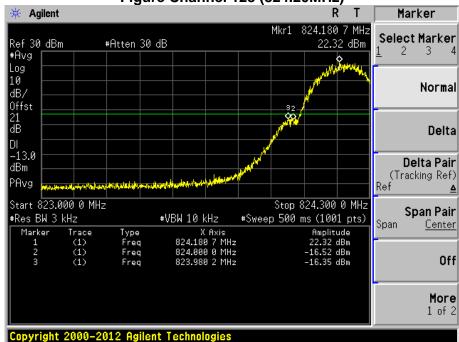


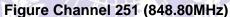




Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 5: EDGE 850 Link			
Date of Test	2014/04/03	Test Site	TR3	



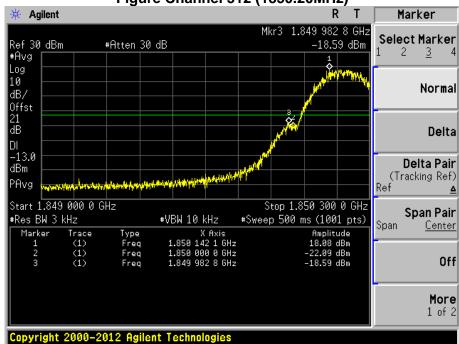


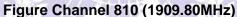




Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 6: EDGE 1900 Link			
Date of Test	2014/04/03	Test Site	TR3	





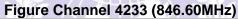




Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 7: WCDMA Band V Link			
Date of Test	2014/04/03	Test Site	TR3	

Figure Channel 4132 (826.40MHz)



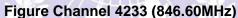


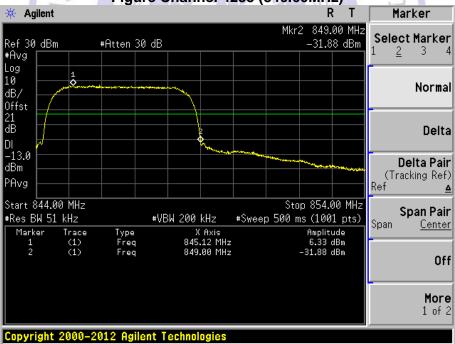


Product	SMART PHONE		
Test Item	Band Edge		
Test Mode	Mode 8: WCDMA Band V HSDPA Link		
Date of Test	2014/04/03	Test Site	TR3

Figure Channel 4132 (826.40MHz)



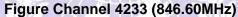




Product	SMART PHONE			
Test Item	Band Edge			
Test Mode	Mode 9: WCDMA Band	d V HSUPA Link		
Date of Test	2014/04/03	Test Site	TR3	

Figure Channel 4132 (826.40MHz)





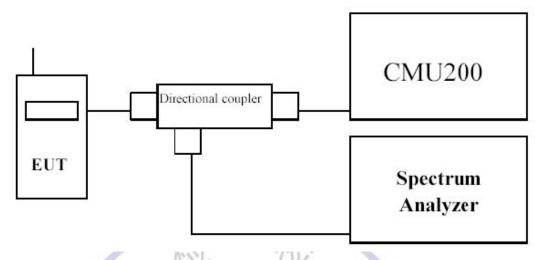


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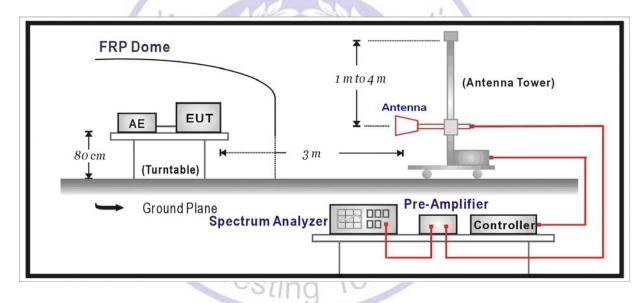
# 4.5. Spurious Emission

## **TEST CONFIGURATION**

Conducted Spurious Measurement:



Radiated Spurious Measurement:



#### **TEST PROCEDURE**

The EUT was setup according to EIA/TIA 603C

# **Conducted Spurious Measurement:**

- a) Place the EUT on a bench and set it in transmitting mode.
- b) Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMU200 by a Directional Couple.
- c) EUT Communicate with CMU200, then select a channel for testing.
- d) Add a correction factor to the display of spectrum, and then test.
- e) The resolution bandwidth of the spectrum analyzer was set at 100 kHz for Part 22 and 1MHz for Part 24 and 27, sufficient scans were taken to show the out of band Emission if any up to 10th harmonic.

#### **Radiated Spurious Measurement:**

a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.

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- b) The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c) The output of the test antenna shall be connected to the measuring receiver.
- d) The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e) The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- g) The test antenna shall be raised and lowered again through the specified range of height until a maximum signal level is detected by the measuring receiver.
- g) The maximum signal level detected by the measuring receiver shall be noted.
- h) The transmitter shall be replaced by a substitution antenna.
- The substitution antenna shall be orientated for vertical polarization and the length of the substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to increase the sensitivity of the measuring receiver.
- The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- m) The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- n) The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- o) The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- p) The resolution bandwidth of the spectrum analyzer was set at 100 kHz for Part 22 and 1MHz for Part 24 and 27. The frequency range was checked up to 10th harmonic. Techni
- g) Test site anechoic chamber refer to ANSI C63.4: 2009

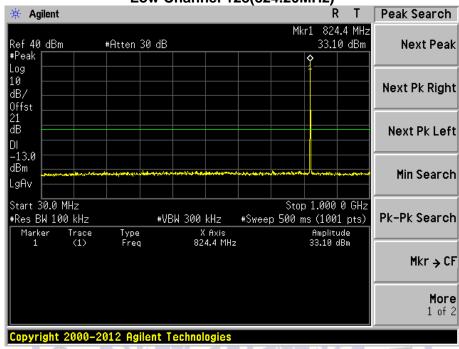
#### LIMIT

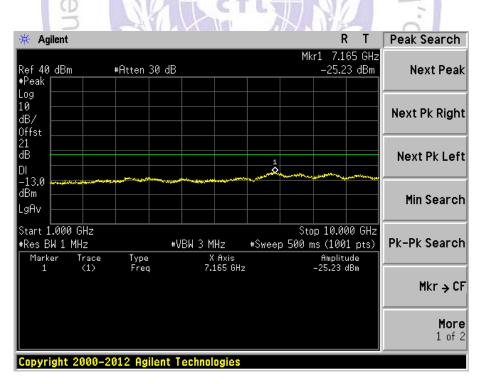
The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10log(P) dB.

## **TEST RESULTS**

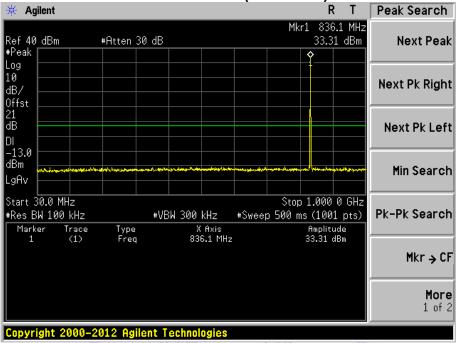
Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 1: GSM 850 Link		
Date of Test	2014/04/03	Test Site	TR3

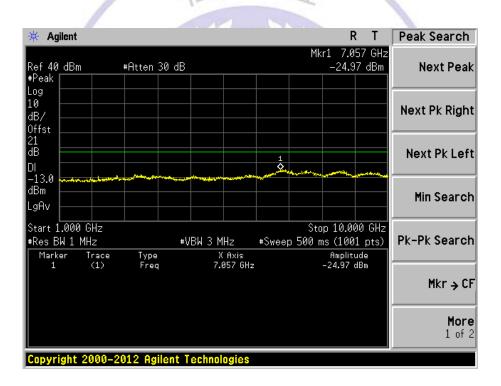




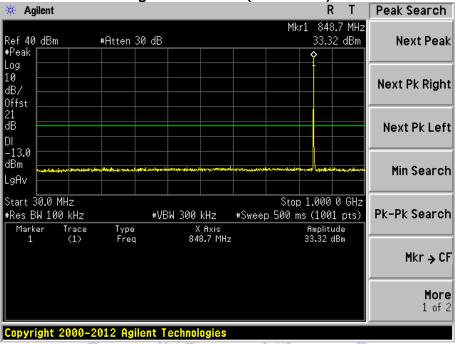


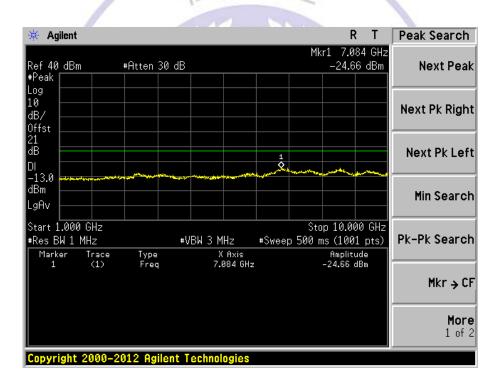
Mid Channel 189(836.40MHz)



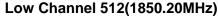


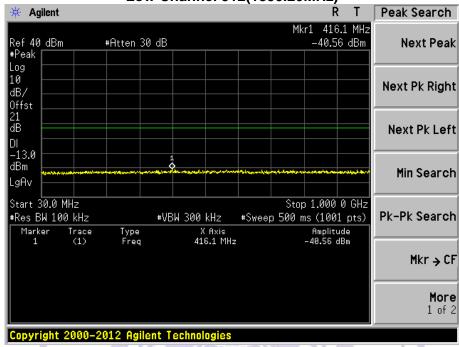
**High Channel 251(848.80MHz)** 

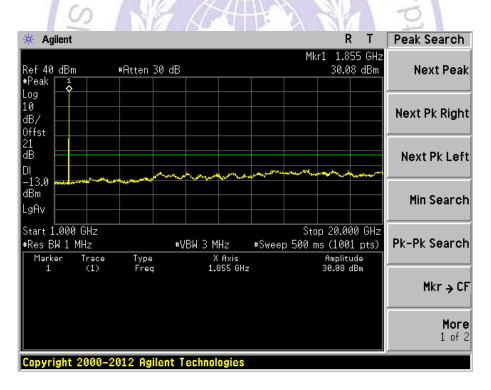




Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 2: GSM 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

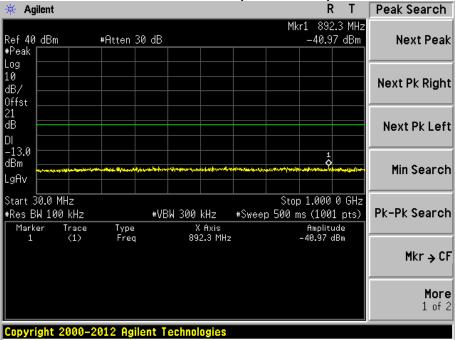


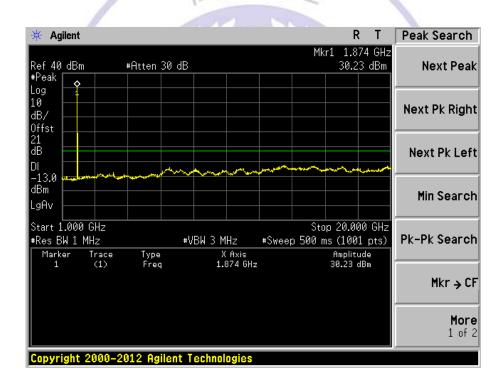




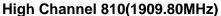


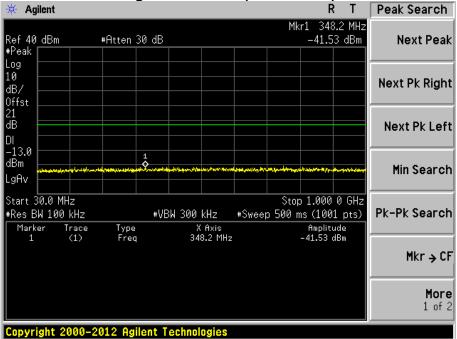


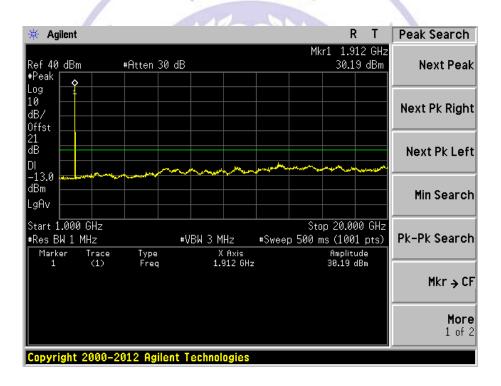




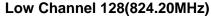


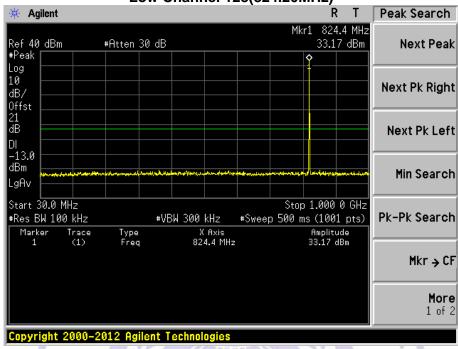


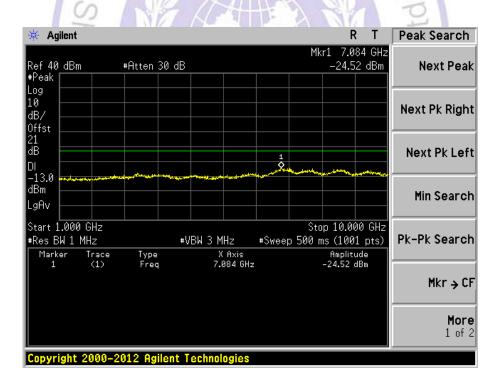




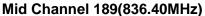
Product	SMART PHONE		
Test Item	Conducted Spurious Emissi	on	
Test Mode	Mode 3: GPRS 850 Link		
Date of Test	2014/04/03	Test Site	TR3

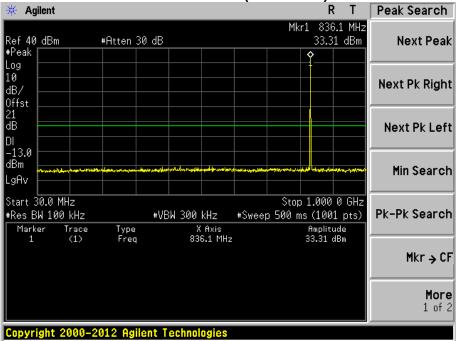


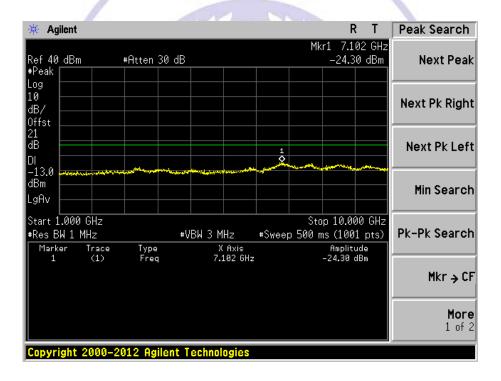






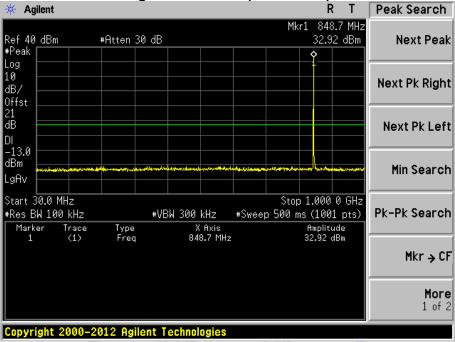


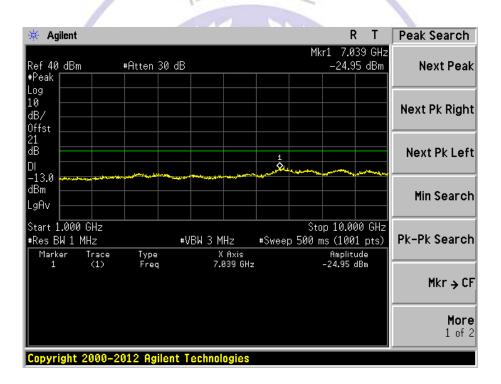




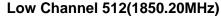


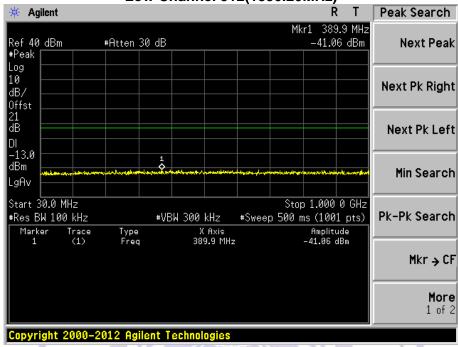


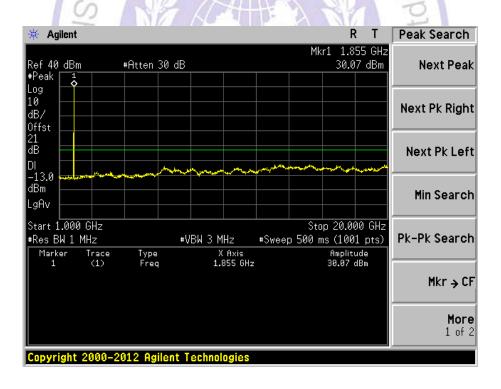




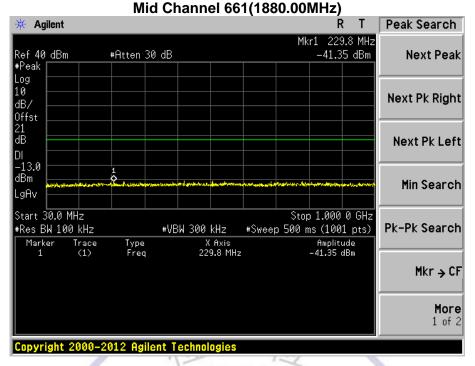
Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 4: GPRS 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

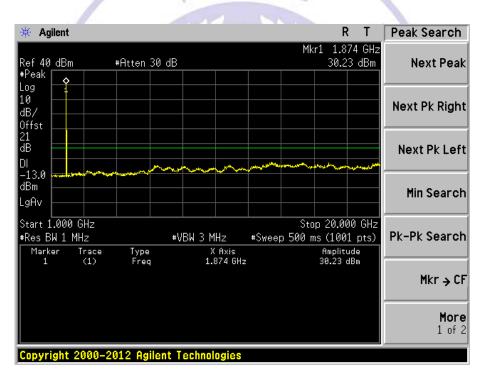


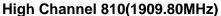


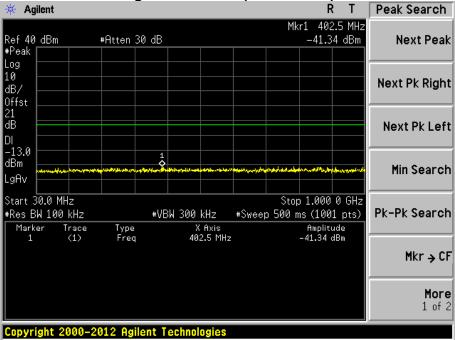


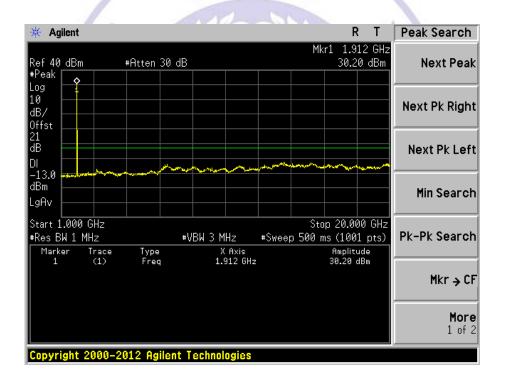






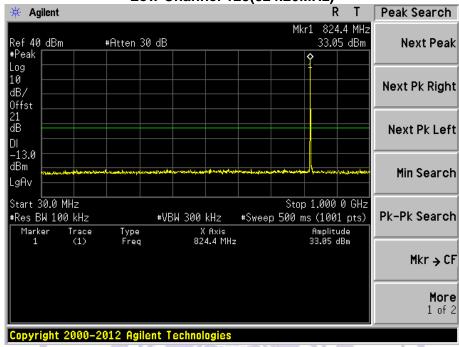


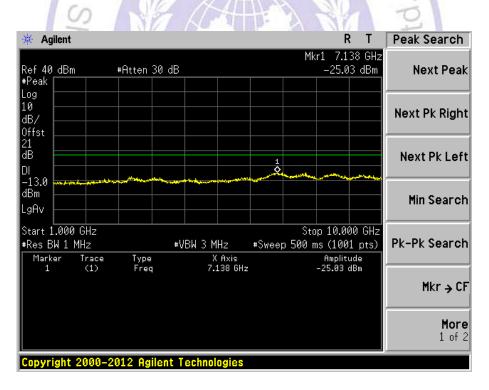




Product	SMART PHONE			
Test Item	Conducted Spurious	s Emission		
Test Mode	Mode 5: EDGE 850	Mode 5: EDGE 850 Link		
Date of Test	2014/04/03	Test Site	TR3	

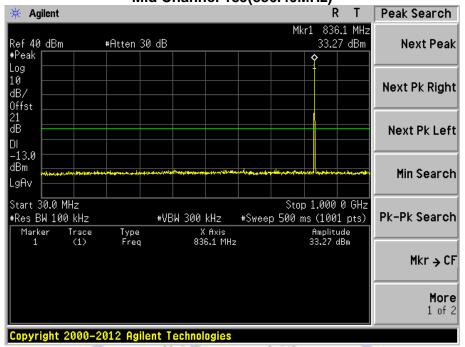


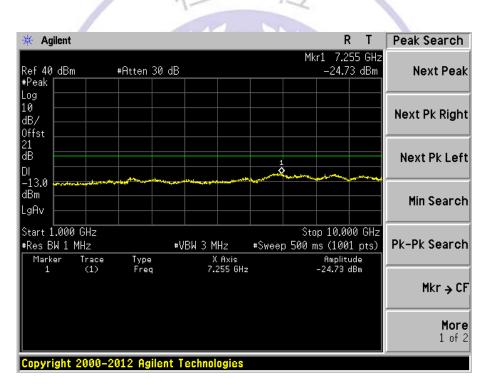




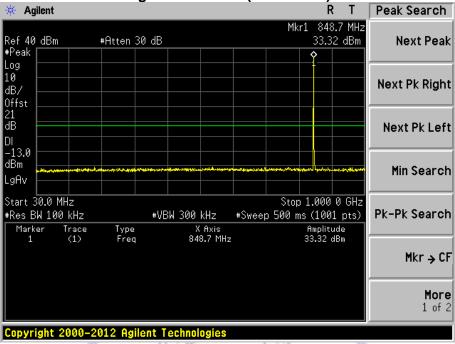
Mid Channel 189(836.40MHz)

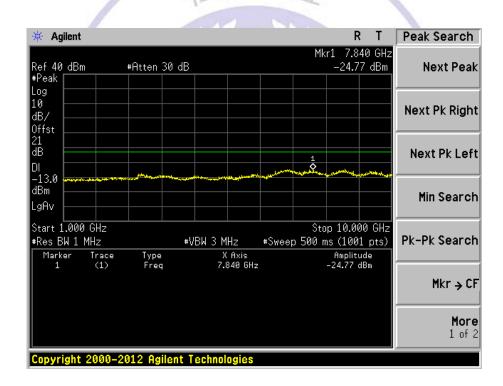
Report No.: CTL1403250553-WU



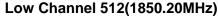


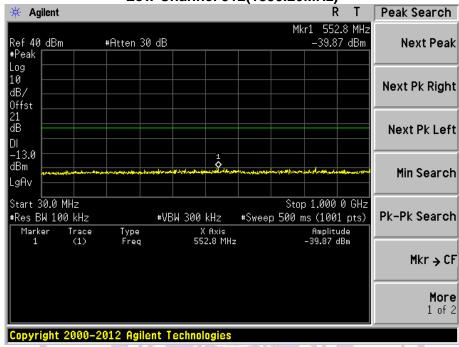
**High Channel 251(848.80MHz)** 

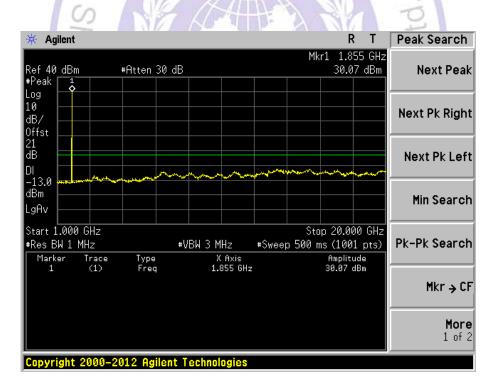




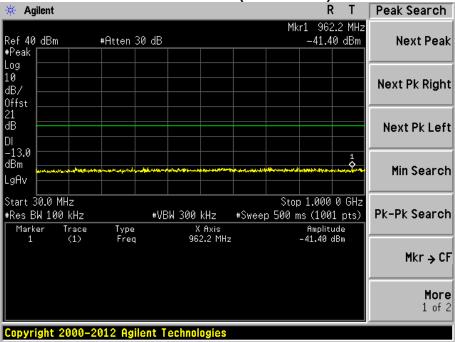
Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 6: EDGE 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

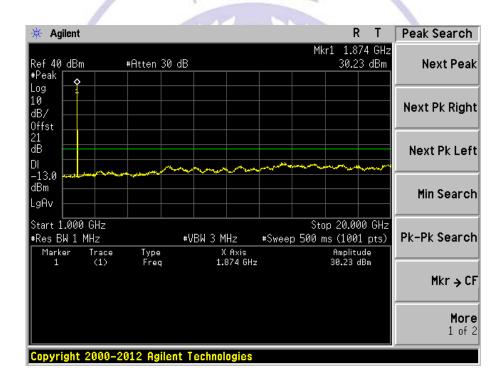


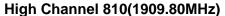


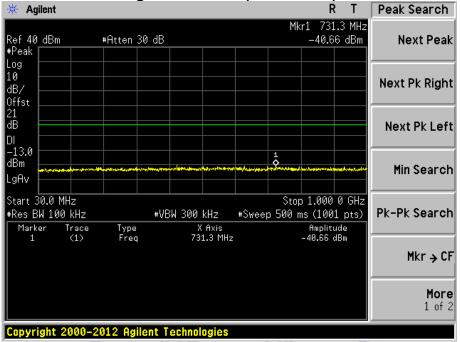


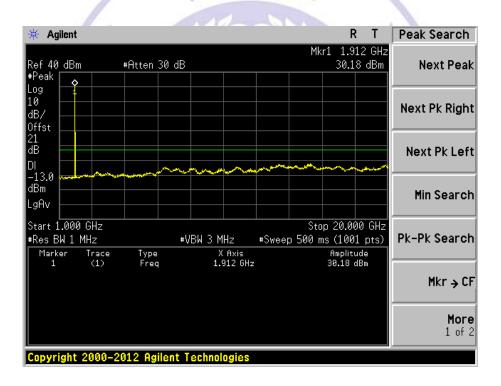
Mid Channel 661(1880.00MHz)





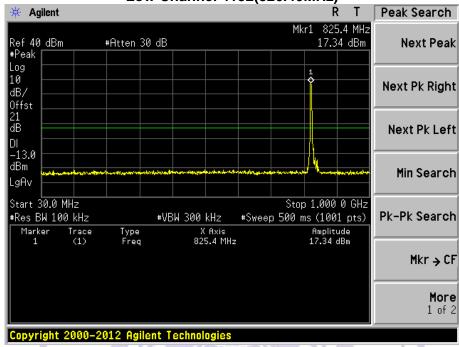


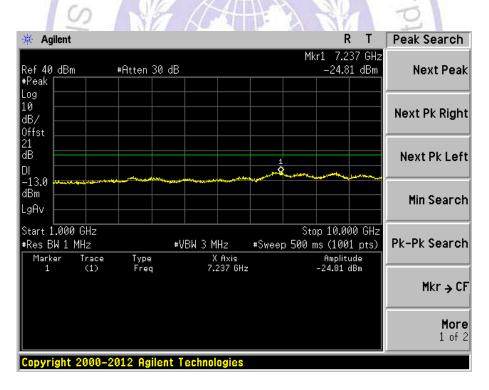




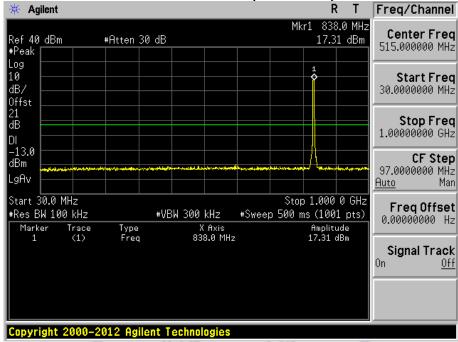
Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 7: WCDMA Band V Link		
Date of Test	2014/04/03	Test Site	TR3

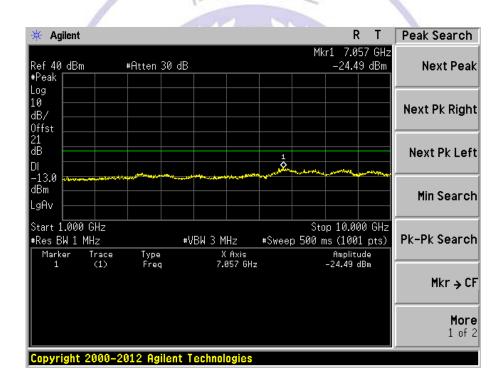




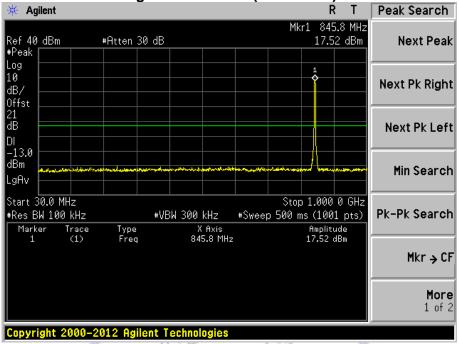


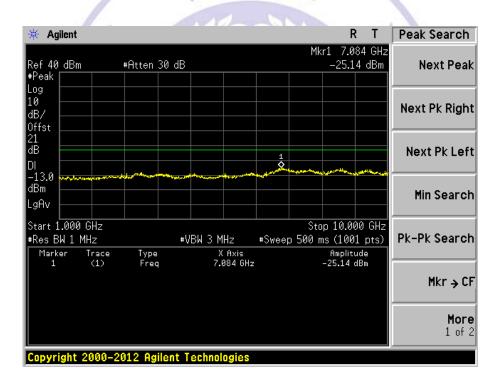






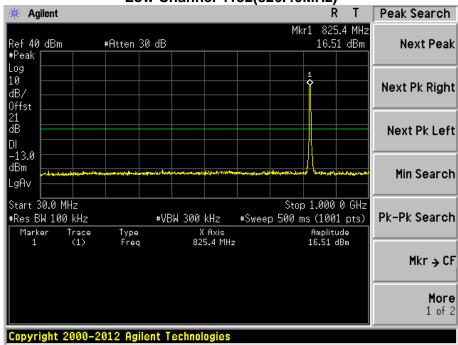
**High Channel 4233(846.60MHz)** 

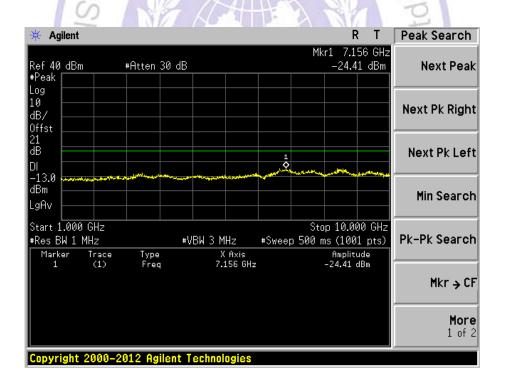




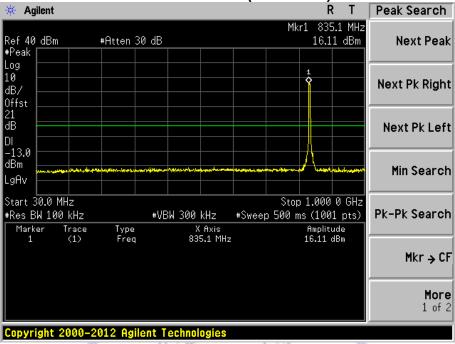
Product	SMART PHONE		
Test Item	Conducted Spurious Emission		
Test Mode	Mode 8: WCDMA Band V HSDPA Link		
Date of Test	2014/04/03	Test Site	TR3

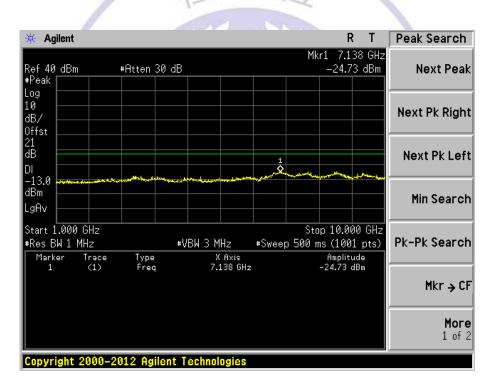




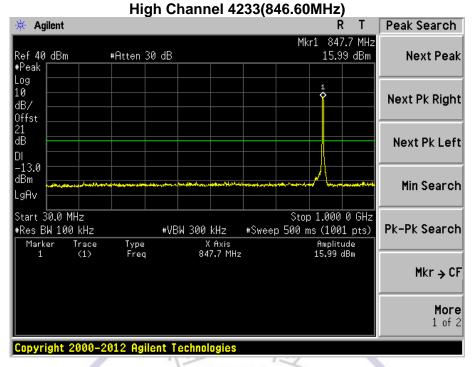


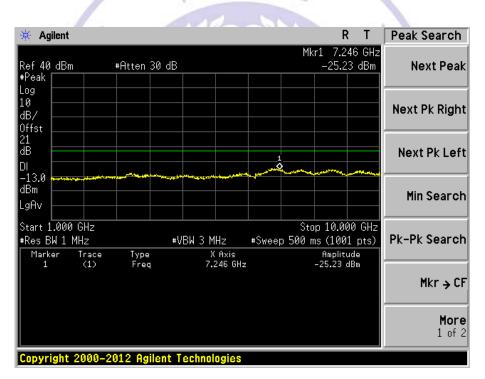
Mid Channel 4182(836.40MHz)





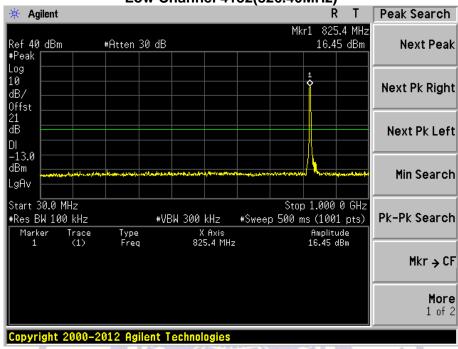


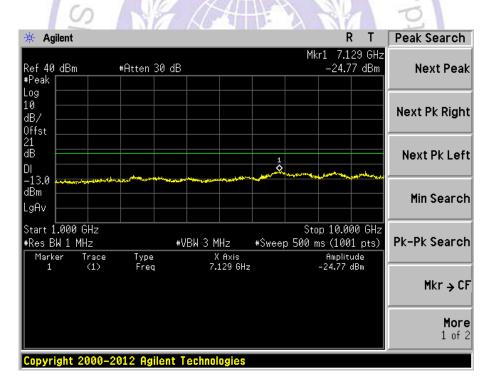




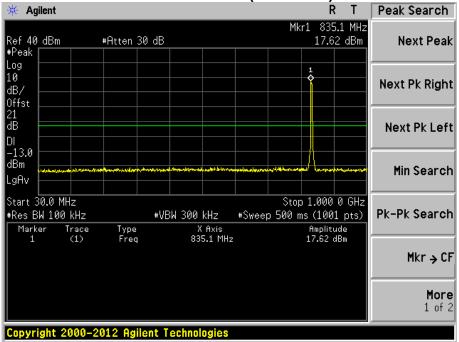
Product	SMART PHONE		
Test Item	Conducted Spurious Emissi	on	
Test Mode	Mode 9: WCDMA Band V H	SUPA Link	
Date of Test	2014/04/03	Test Site	TR3

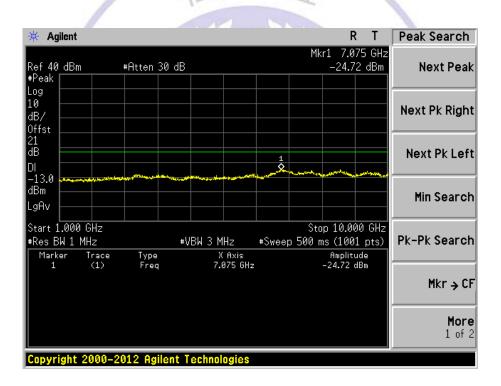




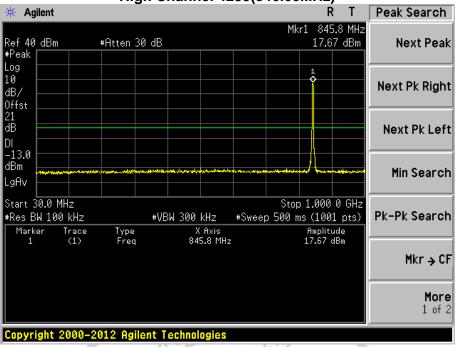


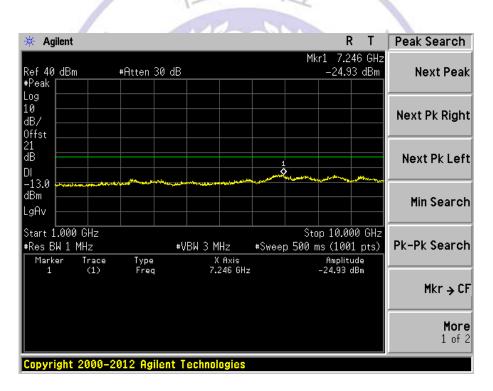






**High Channel 4233(846.60MHz)** 





Product	SMART PHONE		
Test Item	Radiated Spurious Emission	า	
Test Mode	Mode 1: GSM 850 Link		
Date of Test	2014/04/03	Test Site	AC1

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 128 (82	4.20MHz)	)					
1644.0	-57.27	V	-48.62	2.55	5.14	-46.03	-13.0	-33.03
2470.0	-53.29	V	-40.06	3.14	5.54	-37.66	-13.0	-24.66
1644.0	-61.70	Ι	-52.12	2.55	5.14	-49.53	-13.0	-36.53
2428.0	-49.76	Ι	-36.52	3.11	5.46	-34.17	-13.0	-21.17
Middle Char	nnel 189 (	836.40MI	Hz)					
1672.0	-56.28	V	-47.04	2.57	5.05	-44.56	-13.0	-31.56
2428.0	-41.91	V	-29.28	3.11	5.46	-26.93	-13.0	-13.93
1672.0	-65.91	I	-55.90	2.57	5.05	-53.42	-13.0	-40.42
2512.0	-56.21	Η	-43.58	3.18	5.63	-41.13	-13.0	-28.13
High Chann	el 251 (8 <sup>2</sup>	18.80MHz		0		9		
1700.0	-58.01	V	-48.24	2.59	4.96	-45.87	-13.0	-32.87
2540.0	-55.01	V	-41.92	3.19	5.71	-39.40	-13.0	-26.40
2022.0	-41.18	Η	-28.71	2.82	4.46	-27.07	-13.0	-14.07
2540.0	-55.37	H	-42.36	3.19	5.71	-39.84	-13.0	-26.84



Product	SMART PHONE			
Test Item	Radiated Spurious	Emission		
Test Mode	Mode 2: GSM 1900	) Link		
Date of Test	2014/04/03	Test Site	AC1	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Chann	el 512 (18	50.20MH	z)					
3703.0	-47.26	V	-34.44	3.90	7.88	-30.46	-13.0	-17.46
5556.0	-59.93	V	-45.91	4.83	10.10	-40.64	-13.0	-27.64
3703.0	-56.11	Н	-43.14	3.90	7.88	-39.16	-13.0	-26.16
5556.0	-54.96	Н	-40.70	4.83	10.10	-35.43	-13.0	-22.43
Middle Cha	nnel 661 (	1880.00N	ИHz)					
3754.0	-56.12	V	-43.28	3.93	7.91	-39.30	-13.0	-26.30
5641.0	-58.96	V	-44.57	4.94	10.10	-39.41	-13.0	-26.41
3754.0	-53.53	Ι	-40.69	3.93	7.91	-36.71	-13.0	-23.71
5641.0	-56.30	Н	-41.91	4.94	10.10	-36.75	-13.0	-23.75
High Chann	iel 810 (19	909.80MH	lz)	7.	1			
3822.0	-56.30	V	-43.12	3.98	8.07	-39.03	-13.0	-26.03
5726.0	-58.85	V	-44.45	5.00	10.10	-39.35	-13.0	-26.35
3822.0	-54.38	Н	-41.07	3.98	8.07	-36.98	-13.0	-23.98
5726.0	-61.28	J H	-46.76	5.00	10.10	-41.66	-13.0	-28.66



Product	SMART PHONE			
Test Item	Radiated Spurious Emiss	sion		
Test Mode	Mode 3: GPRS 850 Link			
Date of Test	2014/04/03	Test Site	AC1	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 128 (82	4.20MHz)	)					
1644.0	-57.24	V	-48.59	2.55	5.14	-46.00	-13.0	-33.00
2470.0	-51.98	V	-38.75	3.14	5.54	-36.35	-13.0	-23.35
1644.0	-64.04	Н	-54.46	2.55	5.14	-51.87	-13.0	-38.87
2470.0	-60.86	Н	-48.09	3.14	5.54	-45.69	-13.0	-32.69
Middle Char	nnel 189 (	836.40MI	Hz)					
1672.0	-54.75	V	-45.51	2.57	5.05	-43.03	-13.0	-30.03
2512.0	-54.35	V	-41.34	3.18	5.63	-38.89	-13.0	-25.89
1672.0	-62.23	I	-52.21	2.57	5.05	-49.73	-13.0	-36.73
2512.0	-56.54	Η	-43.90	3.18	5.63	-41.45	-13.0	-28.45
High Chann	el 251 (8 <sup>2</sup>	18.80MHz		0		9		
1700.0	-56.80	V	-47.04	2.59	4.96	-44.67	-13.0	-31.67
2540.0	-54.54	V	-41.46	3.19	5.71	-38.94	-13.0	-25.94
1700.0	-57.26	Η	-47.18	2.59	4.96	-44.81	-13.0	-31.81
2540.0	-57.49	H	-44.49	3.19	5.71	-41.97	-13.0	-28.97



Product	SMART PHONE			
Test Item	Radiated Spurious	Emission		
Test Mode	Mode 4: GPRS 190	00 Link		
Date of Test	2014/04/03	Test Site	AC1	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 512 (18	50.20MH	z)					
3703.0	-52.06	V	-39.24	3.90	7.88	-35.26	-13.0	-22.26
5556.0	-62.33	V	-48.31	4.83	10.10	-43.04	-13.0	-30.04
3703.0	-51.33	Н	-38.36	3.90	7.88	-34.38	-13.0	-21.38
5556.0	-60.70	Н	-46.44	4.83	10.10	-41.17	-13.0	-28.17
Middle Cha	nnel 661 (	1880.00N	ИHz)					
3754.0	-55.03	V	-42.04	3.93	7.91	-38.06	-13.0	-25.06
5641.0	-63.50	V	-49.00	4.94	10.10	-43.84	-13.0	-30.84
3754.0	-55.03	Н	-42.19	3.93	7.91	-38.21	-13.0	-25.21
5641.0	-60.35	Н	-45.97	4.94	10.10	-40.81	-13.0	-27.81
High Chann	el 810 (19	909.80MH	lz)	7	N.			
3822.0	-56.00	V	-42.81	3.98	8.07	-38.72	-13.0	-25.72
5726.0	-59.11	V	-44.71	5.00	10.10	-39.61	-13.0	-26.61
3822.0	-59.15	. Н.	-45.84	3.98	8.07	-41.75	-13.0	-28.75
5726.0	-60.16	// H	-45.63	5.00	10.10	-40.53	-13.0	-27.53



Product	SMART PHONE		
Test Item	Radiated Spurious Emission	า	
Test Mode	Mode 5: EDGE 850 Link		
Date of Test	2014/04/03	Test Site	AC5

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 128 (82	4.20MHz)	)					
1648.4	-71.03	V	-61.40	2.55	5.13	-58.82	-13.0	-45.82
2470.0	-58.43	V	-45.66	3.14	5.54	-43.26	-13.0	-30.26
1644.0	-62.63	Н	-53.98	2.55	5.14	-51.39	-13.0	-38.39
2470.0	-68.53	Η	-55.30	3.14	5.54	-52.90	-13.0	-39.90
Middle Cha	nnel 189 (	836.40MI	Hz)					
1672.0	-56.69	V	-47.45	2.57	5.05	-44.97	-13.0	-31.97
2512.0	-58.76	V	-45.76	3.18	5.63	-43.31	-13.0	-30.31
1672.0	-57.28	I	-47.26	2.57	5.05	-44.78	-13.0	-31.78
2512.0	-58.60	Η	-45.97	3.18	5.63	-43.52	-13.0	-30.52
High Chann	el 251 (8 <sup>2</sup>	18.80MHz		0				
1700.0	-62.01	V	-52.25	2.59	4.96	-49.88	-13.0	-36.88
2540.0	-53.81	V	-40.73	3.19	5.71	-38.21	-13.0	-25.21
1700.0	-56.42	Η	-46.35	2.59	4.96	-43.98	-13.0	-30.98
2540.0	-57.35	H	-44.34	3.19	5.71	-41.82	-13.0	-28.82



Product	SMART PHONE		
Test Item	Radiated Spurious Emissio	n	
Test Mode	Mode 6: EDGE 1900 Link		
Date of Test	2014/04/03	Test Site	AC5

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 512 (18	50.20MH	z)					
3703.0	-47.82	V	-35.00	3.90	7.88	-31.02	-13.0	-18.02
5556.0	-63.58	V	-49.55	4.83	10.10	-44.28	-13.0	-31.28
3703.0	-51.94	Ι	-38.97	3.90	7.88	-34.99	-13.0	-21.99
5556.0	-61.25	Н	-46.98	4.83	10.10	-41.71	-13.0	-28.71
Middle Cha	nnel 661 (	1880.00N	1Hz)					
3754.0	-53.72	V	-40.74	3.93	7.91	-36.76	-13.0	-23.76
5641.0	-58.18	V	-43.68	4.94	10.10	-38.52	-13.0	-25.52
3754.0	-55.15	I	-42.31	3.93	7.91	-38.33	-13.0	-25.33
5641.0	-60.25	Н	-45.87	4.94	10.10	-40.71	-13.0	-27.71
High Chann	iel 810 (19	909.80MH	lz)	1	X			
3822.0	-56.51	V	-43.32	3.98	8.07	-39.23	-13.0	-26.23
5726.0	-55.82	V	-41.42	5.00	10.10	-36.32	-13.0	-23.32
3822.0	-57.73	y H	-44.42	3.98	8.07	-40.33	-13.0	-27.33
5726.0	-61.39	$\mathcal{L}$ H	-46.87	5.00	10.10	-41.77	-13.0	-28.77



Product	SMART PHONE			
Test Item	Radiated Spurious Emission			
Test Mode	Mode 7: WCDMA Band V Traffic			
Date of Test	2014/04/03	Test Site	AC5	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 4132 (8	26.40MH	z)					
1652.8	-70.79	V	-62.01	2.56	5.11	-59.46	-13.0	-46.46
2484.0	-63.67	V	-50.72	3.15	5.57	-48.30	-13.0	-35.30
1658.0	-68.35	Ι	-58.55	2.56	5.09	-56.02	-13.0	-43.02
2479.2	-66.18	Ι	-53.53	3.15	5.56	-51.12	-13.0	-38.12
Middle Chai	nnel 4182	(836.40N	1Hz)					
1672.0	-68.91	V	-59.67	2.57	5.05	-57.19	-13.0	-44.19
2512.0	-63.22	V	-50.22	3.18	5.63	-47.77	-13.0	-34.77
1672.8	-70.43	I	-60.40	2.57	5.05	-57.92	-13.0	-44.92
2526.0	-62.61	Η	-49.79	3.19	5.67	-47.31	-13.0	-34.31
High Chann	High Channel 4233 (846.60MHz)							
1700.0	-67.38	V	-57.62	2.59	4.96	-55.25	-13.0	-42.25
2540.0	-62.68	V	-49.60	3.19	5.71	-47.08	-13.0	-34.08
1686.0	-68.45	Η	-58.33	2.58	5.01	-55.90	-13.0	-42.90
2526.0	-64.36	. Н	-51.55	3.19	5.67	-49.07	-13.0	-36.07



Product	SMART PHONE			
Test Item	Radiated Spurious Emission			
Test Mode	Mode 8: WCDMA Band V HSDPA Traffic			
Date of Test	2014/04/03	Test Site	AC5	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 4132 (8	26.40MH	z)					
1652.8	-70.54	V	-61.76	2.56	5.11	-59.21	-13.0	-46.21
2484.0	-64.70	V	-51.75	3.15	5.57	-49.33	-13.0	-36.33
1652.8	-70.24	Н	-60.52	2.56	5.11	-57.97	-13.0	-44.97
2480.0	-66.26	Н	-53.62	3.15	5.56	-51.21	-13.0	-38.21
Middle Cha	nnel 4182	(836.401)	1Hz)					
1672.8	-70.64	V	-61.38	2.57	5.05	-58.90	-13.0	-45.90
2512.0	-61.41	V	-48.41	3.18	5.63	-45.96	-13.0	-32.96
1672.8	-71.07	I	-61.04	2.57	5.05	-58.56	-13.0	-45.56
2512.0	-64.20	Н	-51.57	3.18	5.63	-49.12	-13.0	-36.12
High Chann	High Channel 4233 (846.60MHz)							
1700.0	-70.58	V	-60.81	2.59	4.96	-58.44	-13.0	-45.44
2540.0	-64.46	V	-51.37	3.19	5.71	-48.85	-13.0	-35.85
1784.0	-62.68	Н	-52.47	2.64	4.75	-50.36	-13.0	-37.36
2526.0	-62.64	, H	-49.82	3.19	5.67	-47.34	-13.0	-34.34



Product	SMART PHONE			
Test Item	Radiated Spurious Emission			
Test Mode	Mode 9: WCDMA Band V HSUPA Traffic			
Date of Test	2014/04/03	Test Site	AC5	

Frequency	SA	Ant.Pol.	SG	Cable	Gain	EIRP	Limit	Margin
(MHz)	Reading	(H/V)	Reading	Loss	(dBi)	(dBm)	(dBm)	(dB)
	(dBm)		(dBm)	(dB)				
Low Channe	el 4132 (8	26.40MH	z)					
1652.8	-70.67	V	-61.89	2.56	5.11	-59.34	-13.0	-46.34
2484.0	-66.02	V	-53.07	3.15	5.57	-50.65	-13.0	-37.65
1652.8	-70.68	Ι	-60.97	2.56	5.11	-58.42	-13.0	-45.42
2526.0	-62.07	Ι	-49.26	3.19	5.67	-46.78	-13.0	-33.78
Middle Chai	nnel 4182	(836.40N	1Hz)					
1672.8	-69.59	V	-60.33	2.57	5.05	-57.85	-13.0	-44.85
2512.0	-66.12	V	-53.11	3.18	5.63	-50.66	-13.0	-37.66
1672.8	-70.71	I	-60.68	2.57	5.05	-58.20	-13.0	-45.20
2512.0	-64.08	Η	-51.44	3.18	5.63	-48.99	-13.0	-35.99
High Chann	High Channel 4233 (846.60MHz)							
1693.2	-70.04	V	-60.38	2.59	4.98	-57.99	-13.0	-44.99
2526.0	-65.87	V	-52.62	3.19	5.67	-50.14	-13.0	-37.14
1693.2	-71.24	Η	-61.13	2.59	4.98	-58.74	-13.0	-45.74
2526.0	-65.18	H	-52.37	3.19	5.67	-49.89	-13.0	-36.89

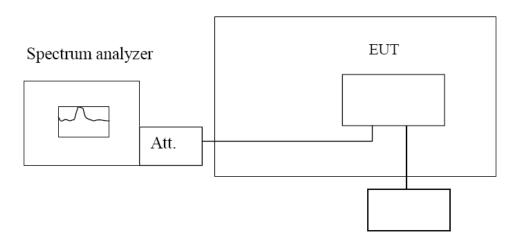


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## 4.6. Frequency Stability under Temperature & Voltage Variations

#### **TEST CONFIGURATION**

# Temperature Chamber



Variable Power Supply

## **TEST PROCEDURE**

The EUT was setup according to EIA/TIA 603C

#### Frequency Stability Under Temperature Variations:

The equipment under test was connected to an external AC or DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT  $20^{\circ}$ C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with  $10^{\circ}$ C increased per stage until the highest temperature of +50°C reached.

### Frequency Stability Under Voltage Variations:

Set chamber temperature to  $20^{\circ}$ C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.

### **LIMIT**

The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Limit  $< \pm 2.5 \text{ ppm}$ 

# **TEST RESULTS**

Product	SMART PHONE		
Test Item	Frequency Stability Under Temperat	ture & Voltage Va	riations
Test Mode	Mode 1: GSM 850 Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

	1	•	
Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	49	± 2091
-20	836.40	32	± 2091
-10	836.40	-30	± 2091
0	836.40	-27	± 2091
10	836.40	-25	± 2091
20	836.40	-22	± 2091
30	836.40	18	± 2091
40	836.40	-49	± 2091
50	836.40	8	± 2091

DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)				
3.5	836.40	-21	± 2091				
3.7	836.40	11/	± 2091				
4.2	836.40	-53	± 2091				
Cy Zachnolos							
	estir	ng lec					

Product	SMART PHONE		
Test Item	Frequency Stability Under T	emperature & Voltage \	/ariations
Test Mode	Mode 2: GSM 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	1880.00	-27	± 4700
-20	1880.00	51	± 4700
-10	1880.00	6	± 4700
0	1880.00	-51	± 4700
10	1880.00	39	± 4700
20	1880.00	10	± 4700
30	1880.00	-46	± 4700
40	1880.00	29	± 4700
50	1880.00	-72	± 4700

DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	1880.00	-44	± 4700
3.7	1880.00	25	± 4700
4.2	1880.00	-58	± 4700
	Chi Testir	ng Technolo	5

Product	SMART PHONE		
Test Item	Frequency Stability Under Temperat	ure & Voltage Va	riations
Test Mode	Mode 3: GPRS 850 Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

	· · · · · · · · · · · · · · · · · · ·		
Temperature Interval (°C)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	44	± 2091
-20	836.40	32	± 2091
-10	836.40	-40	± 2091
0	836.40	-32	± 2091
10	836.40	-34	± 2091
20	836.40	-30	± 2091
30	836.40	22	± 2091
40	836.40	-39	± 2091
50	836.40	10	± 2091

DC Voltag (V)	е	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	9	836.40	23	± 2091
3.7	20	836.40	-42	± 2091
4.2	U.	836.40	-30	± 2091
	1	C72 Testin	ng Technolo	5

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Product	SMART PHONE		
Test Item	Frequency Stability Under Te	emperature & Voltage \	/ariations
Test Mode	Mode 4: GPRS 1900 Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	1880.00	-27	± 4700
-20	1880.00	45	± 4700
-10	1880.00	-30	± 4700
0	1880.00	-34	± 4700
10	1880.00	47	± 4700
20	1880.00	19	± 4700
30	1880.00	-45	± 4700
40	1880.00	40	± 4700
50	1880.00	55	± 4700

Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)			
1880.00	-50\	± 4700			
1880.00	41	± 4700			
1880.00	26	± 4700			
4.2 1880.00 26 ± 4700					
	(MHz) 1880.00 1880.00 1880.00	(MHz) (Hz)  1880.00 -50  1880.00 41  1880.00 26			

Product	SMART PHONE		
Test Item	Frequency Stability Under Temperate	ure & Voltage Va	riations
Test Mode	Mode 5: EDGE 850 Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

	<u> </u>		
Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	2	± 2091
-20	836.40	-32	± 2091
-10	836.40	45	± 2091
0	836.40	-39	± 2091
10	836.40	14	± 2091
20	836.40	-53	± 2091
30	836.40	12	± 2091
40	836.40	-74	± 2091
50	836.40	29	± 2091

DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	836.40	-32	± 2091
3.7	836.40	27	± 2091
4.2	836.40	-48	± 2091

Product SMART PHONE

Test Item Frequency Stability Under Temperature & Voltage Variations

Test Mode Mode 6: EDGE 1900 Link

Date of Test 2014/04/03 Test Site TR3

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Frequency Stability under Temperature

Temperature Interval (°C)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	1880.00	-58	± 4700
-20	1880.00	38	± 4700
-10	1880.00	-22	± 4700
0	1880.00	-52	± 4700
10	1880.00	-49	± 4700
20	1880.00	-50	± 4700
30	1880.00	-36	± 4700
40	1880.00	5	± 4700
50	1880.00	-24	± 4700

DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	1880.00	20	± 4700
3.7	1880.00	-28	± 4700
4.2	1880.00	20	± 4700

Product	SMART PHONE		
Test Item	Frequency Stability Under Tem	perature & Voltage	Variations
Test Mode	Mode 7: WCDMA Band V Link		
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

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Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	50	± 2091
-20	836.40	-51	± 2091
-10	836.40	-46	± 2091
0	836.40	40	± 2091
10	836.40	-58	± 2091
20	836.40	28	± 2091
30	836.40	-48	± 2091
40	836.40	16	± 2091
50	836.40	28	± 2091

DC Voltage (V)		Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	0	836.40	-43	± 2091
3.7	7.0	836.40	20	± 2091
4.2	5	836.40	-60	± 2091
	Oli	Chi Testir	Technolo	5

Product	SMART PHONE		
Test Item	Frequency Stability Under Temperat	ure & Voltage Va	riations
Test Mode	Mode 8: WCDMA Band V HSDPA Li	nk	
Date of Test	2014/04/03	Test Site	TR3

Frequency Stability under Temperature

Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	48	± 2091
-20	836.40	-47	± 2091
-10	836.40	-37	± 2091
0	836.40	53	± 2091
10	836.40	29	± 2091
20	836.40	28	± 2091
30	836.40	-47	± 2091
40	836.40	22	± 2091
50	836.40	-58	± 2091

DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	836.40	20	± 2091
3.7	836.40	32	± 2091
4.2	836.40	19	± 2091

Product	SMART PHONE			
Test Item	Frequency Stability Und	er Temperature & Voltage Variations		
Test Mode	Mode 9: WCDMA Band	Mode 9: WCDMA Band V HSUPA Link		
Date of Test	2014/04/03	Test Site TR3		

Frequency Stability under Temperature

Temperature Interval (℃)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
-30	836.40	58	± 2091
-20	836.40	-37	± 2091
-10	836.40	-37	± 2091
0	836.40	43	± 2091
10	836.40	-58	± 2091
20	836.40	21	± 2091
30	836.40	-61	± 2091
40	836.40	32	± 2091
50	836.40	21	± 2091

Frequency Stability under Voltage

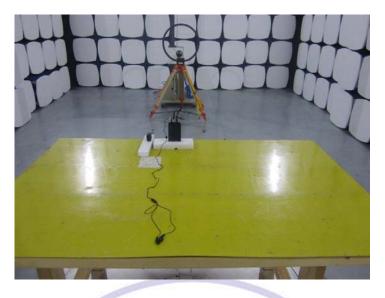
DC Voltage (V)	Test Frequency (MHz)	Deviation (Hz)	Limit (Hz)
3.5	836.40	-35	± 2091
3.7	836.40	23	± 2091
4.2	836.40	34	± 2091

## Note:

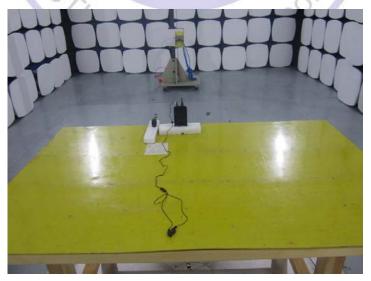
1. Normal Voltage: 3.7V

esting Technology 2. Battery End Point(BEP) = 3.4V

# 5. Test Setup Photos of the EUT







# 6. External and Internal Photos of the EUT

## **External Photos of EUT**















## **Internal Photos of EUT**

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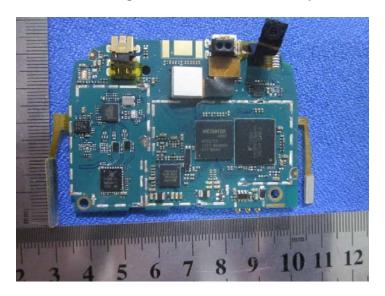




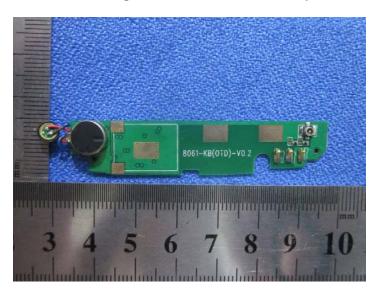


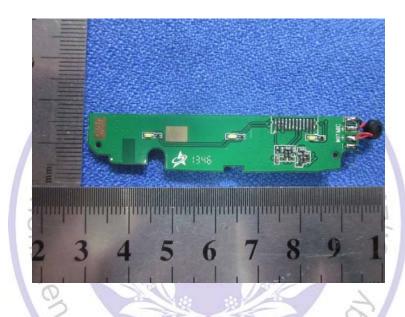












.....End of Report.....